



Reliability Report – 54HCT04

High Speed CMOS TTL Input - Hex Inverter with LSTTL compatible inputs

MIL-PRF-38534 CLASS K QUALIFICATION DATAPACK

Performed by Tandex Test Labs



TANDEX

15849 Business Center Drive, Irwindale, CA 91706, U.S.A.

Phone (626) 962-7166, Fax (626) 960-6896

www.tandexlabs.com

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MIL-PRF-38534 CLASS K DATAPACK

Certificate of Conformance



TANDEX TEST LABS, INC.

15849 Business Center. Dr., Irwindale CA. 91706 U.S.A.

Phone: (626)962-7166 FAX: (626)960-6896

<http://www.tandexlabs.com>



e-mail: via web site

Certificate of Conformance

CUSTOMER:	SILICON SUPPLIES LIMITED	DATE: November 12, 2018
	47 WHERRY ROAD NORWICH, NR1, 1WS UNITED KINGDOM VAT GB#114 3513 56	
TEST REPORT:	DDS-101-13-A	QUANTITY RECEIVED: 30 DIE
P.O. NUMBER:	SS139	QUANTITY REQUIRED: 10/5/8
DESCRIPTION:	CMOS LOGIC MICROCIRCUIT	QUANTITY PROCESSED: 17
PART NUMBER(S):	54HCT04	QUANTITY PASSED: 17
P/N: AS RECEIVED / MFG. PART NUMBER:	54HCT04	QUANTITY FAILED: 0
LOT / DATE CODE:	1810 LOT# 80393 WF48	
MANUFACTURE: CAGE CODE:	SILICON SUPPLIES	QUANTITY SHIPPING: 17*
TANDEX CAGE CODE:	1FE65	INCLUDES: 10 PROCESS ACCEPT 2 SPARES 5 BOND PULL SAMPLES **8 DIE TRANSFERRED TO DDS-101-13-W FOR SEM.

METHOD OF TESTING: MIL-PRF-38534 CL. K, MIL-STD-883

I hereby certify that the subject components have been processed and inspected in accordance with instructions with specifications referenced in your purchase order. Physical records and/or data pertinent to applicable military, proprietary, and/or commercial specifications are on file and available upon request for inspection at this facility.

Linda S. Sepulveda
QUALITY ASSURANCE



MIL-PRF-38534 CLASS K DATAPACK

Process Flow Chart + Mechanical Test Results



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PROCESS FLOW CHART

FLOW NUMBER: DDS-101-13-A REV. 0

CUSTOMER: DIE DEVICES P.O. NUMBER: SS139
 PART NUMBER: 54HCT04 P/N AS RECEIVED: 54HCT04
 PART TYPE: CMOS LOGIC MICROCIRCUIT DRAWING: MIL-PRF-38534 CL K, MIL-STD-883
 DUE DATE: 7/12/18 JOB NUMBER: DDS-101-13-A
 LDC AS RECEIVED: 1810 LOT# 80393 WF48 QUANTITY RECEIVED : 30 (DIE)
 QUOTE NUMBER: DDS14267-1 MFG: SILICON SUPPLIES QUANTITY REQUIRED : 10/5/8

CAUTION: ESD REFER TO TTL DRAWING #P1025

01	FLO	P-1015 P-1223	FLOW PREPARED BY: <u>LSS</u> ON: <u>3/29/18</u> CONTRACTUAL AGREEMENT REVIEW Y N NOT SPECIFIED <input type="checkbox"/> <input checked="" type="checkbox"/> <input checked="" type="checkbox"/> Q-CLAUSES <input type="checkbox"/> <input checked="" type="checkbox"/> <input type="checkbox"/> DPAS <input type="checkbox"/> <input checked="" type="checkbox"/> <input type="checkbox"/> DFAR <input type="checkbox"/> <input checked="" type="checkbox"/> <input type="checkbox"/> ITAR <input type="checkbox"/> <input type="checkbox"/> OTHER SPECIFIED							QA TANDEX 5
02	QCI		TANDEX QUALITY CONTROL INSPECTION. FLOW APPROVED BY: <u>JMI</u> ON: <u>3/29/18</u>							
03	RCV	P-1070	VERIFY PART NUMBER. ENTER INTO INCOMING LOG. <u>X</u> CUSTOMER COUNT	30				3/29/18		QA TANDEX 5
SEQ	PROC	REF #	DESCRIPTION	QTY	REJ	ACCEPT	DATE	INSP.		
04	VIS	P-1041	PERFORM 100% DIE VISUAL PER MIL-STD-883 METHOD 2010 AND MIL-PRF-38534 PARA C.3.3.2. EQUIPMENT USED: <u>Olympus</u> ASSET #: <u>20091</u>	30	0	30	5/10/18			TTL
			ESD MAT DUE DATE: <u>5/27/18</u>							
05	ASSY	P-1029	PACKAGE SUFFICIENT DEVICES FOR CLASS K ELEMENT EVALUATION / ELECTRICAL AND BOND PULL PER MIL-PRF-38534 REFERENCE DIE GEOMETRY FOR ORIENTATION AND PIN - OUTS. DIE ATTACH: SCREENING EUTETIC BOND PULL Lot#: <u>149555</u> Exp. Date: <u>N/A</u> SEM TRANSFER TO DDS-101-13-W MIL-STD-883 METHOD 2018 * Package Type: 14 PIN DIP	10+2 5 8	0 0 0	10+2 5 6	5/24/18 5/24/18 5/10/18			TTL 30 TTL 30 TTL
			ESD MAT DUE DATE: <u>6/27/18</u>							
		P-4010	WIRE BOND: Utilize 1 Mil Au Wire (.001) 1 Mil Au bonder <u>MECH-EL</u> Asset #: <u>20060</u> Gold Wire: Lot# <u>9001882915</u> Exp. Date: <u>3/2019</u>	17	0	17	5/24/18			TTL 30

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PROCESS FLOW CHART

FLOW NUMBER: DDS-101-13-A REV. 0

CUSTOMER: DIE DEVICES P.O. NUMBER: SS139
 PART NUMBER: 54HCT04 P/N AS RECEIVED: 54HCT04
 PART TYPE: CMOS LOGIC MICROCIRCUIT DRAWING: MIL-PRF-38534 CL K, MIL-STD-883
 DUE DATE: 7/12/18 JOB NUMBER: DDS-101-13-A
 LDC AS RECEIVED: 1810 LOT# 80393 WF48 QUANTITY RECEIVED: 30 (DIE)
 QUOTE NUMBER: DDS14267-1 MFG: SILICON SUPPLIES QUANTITY REQUIRED: 10/5/8

CAUTION: ESD REFER TO TTL DRAWING #P1025

SEQ	PROC	REF #	DESCRIPTION	QTY	REJ	ACCEPT	DATE	INSP.
06	VIS		PERFORM 100% INTERNAL VISUAL PER MIL-STD-883 METHOD 2010 & MIL-PRF-38534 C.3.3.3, C.3.3.4.2. EQUIPMENT USED: <u>NIKON SM2645</u> , ASSET #: <u>30663</u>	17	2	17	5/29/18	TTL 30
ESD MAT DUE DATE: 6/27/18								
07	SEAL		SEAL DEVICES VACUUM BAKE: Pre Seal Bake Time: Temp: <u>125°C</u> Time: <u>24 hrs</u> Actual time in: <u>7:36 am - 5/29/18</u> Actual time out: <u>9:25 am</u> FURNACE LDC STAMP Actual temp: <u>125°C</u> 1821 TTL 27	10+2	0	12	5/30/18	TTL 27
ESD MAT DUE DATE: 6/27/18								
08	ELEC		PERFORM 100% ELECTRICAL VERIFICATION TEST PER MFG DATA SHEET AND MIL-PRF-38534 @ AMBIENT OPERATING TEMPERATURE GO / NO GO EQUIPMENT USED: <u>Sony</u> , ASSET#: <u>1093</u> +25°C TEST FIXTURE: <u>1377/1201</u> SOFTWARE ID: <u>4HCT04 REV N/A</u>	10+2	0	10+2	6/01/18	CTM
ESD MAT DUE DATE: 1/1/18								
09	TEMP		PERFORM TEMPERATURE CYCLING PER MIL-STD-883 METHOD 1010 CONDITION C & MIL-PRF-38534 C.3.3.3. TEN (10) CYCLES DATE IN TIME IN TA = -65°C +0/-10 to +150°C +15/-0 10 MINUTES AT EXTREMES DATE OUT TIME OUT EQUIPMENT USED: <u>DELTA DESIGN</u> , ASSET #: <u>30626</u> EQUIPMENT USED: <u>OMEGA HH309A</u> , ASSET #: <u>31567</u>	10+2	0	10+2	6/4/18 6:44A.M.	TTL 48
ESD MAT DUE DATE: 6/27/18								
10	ACCE		PERFORM CONSTANT ACCELERATION PER MIL-PRF-38534 MIL-STD-883 METHOD 2001. Y1 DIRECTION ONLY @ 3000 G's (min) EQUIPMENT USED: <u>TRIO Tech</u> , ASSET #: <u>30260</u>	10+2	0	10+2	6/5/18	TTL 52 TTL 71
ESD MAT DUE DATE: 6/27/18								
11	SER		SERIALIZE S/N: <u>01-10 1-12</u> ✓ <u>4/6/18</u>	10+2	0	10+2	6/7/18	TTL 33
ESD MAT DUE DATE: 6/27/18								

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PROCESS FLOW CHART

FLOW NUMBER: DDS-101-13-A REV. 0

CUSTOMER: DIE DEVICES P.O. NUMBER: SS139
 PART NUMBER: 54HCT04 P/N AS RECEIVED: 54HCT04
 PART TYPE: CMOS LOGIC MICROCIRCUIT DRAWING: MIL-PRF-38534 CL K, MIL-STD-883
 DUE DATE: 7/12/18 JOB NUMBER: DDS-101-13-A
 LDC AS RECEIVED: 1810 LOT# 80393 WF48 QUANTITY RECEIVED: 30 (DIE)
 QUOTE NUMBER: DDS14267-1 MFG: SILICON SUPPLIES QUANTITY REQUIRED: 10/5/8

CAUTION: ESD REFER TO TTL DRAWING #P1025

SEQ	PROC	REF #	DESCRIPTION	QTY	REJ	ACCEP	DATE	INSP.
12	ELEC		PERFORM 100% ELECTRICAL VERIFICATION PER MFG DATA SHEET3 AND MIL-PRF-38534 C.3.3.4.3 @ AMBIENT , HIGH AND LOW OPERATING TEMPERATURES. READ AND RECORD. STATIC AND FUNCTIONAL TESTS +25°C -55°C +125°C EQUIPMENT USED: <u>Sentry</u> ASSET#: <u>1093</u> TEST FIXTURE: <u>1377/1201</u> SOFTWARE ID: <u>4HCT04</u> REV _____ TEMPERATURE SOAK <u>10</u> SEC.	12 12 12	0 0 0	12 12 12	8/1/18 8/20/18 8/20/18	ctm TTL 10 TTL 10
13	BI		PERFORM BURN IN PER BURN IN CIRCUIT PER FIGURE 1 OF DWG# 1026-16668, AND MIL-STD 883 METHOD 1015. TA = 125°C (min) T = 240 HRS (min) BURN-IN BOARD # / DESC: <u>31250</u> BURN-IN OVEN #: <u>21</u>	12 12	0 0	12 12	8/30/18 6:00AM 9/10/18 6:00AM	TTL 13 TTL 13
14	ELEC		PERFORM POST BURN IN ELECTRICAL VERIFICATION PER MFG DATA SHEET AND MIL-PRF-38534 C.3.3.4.3 @ AMBIENT, HIGH AND LOW OPERATING TEMPERATURES. READ AND RECORD. STATIC AND FUNCTIONAL TESTS +25°C -55°C +125°C <u>TEST +25°C WITHIN 96 HOURS</u> EQUIPMENT USED: <u>Sentry</u> ASSET#: <u>1093</u> TEST FIXTURE: <u>1377/1201</u> SOFTWARE ID: <u>4HCT04</u> REV _____ TEMPERATURE SOAK <u>10</u> SEC.	12 12 12	0 0 0	12 12 12	9/10/18 9/10/18 9/10/18	TTL 27 TTL 27 TTL 27
15	ER		PER PO REQUIREMENTS: REVIEW AT POST 240 HR. BURN-IN EMAIL: <u>ben.white@diodevices.com</u> POST 240 HR BURN-IN ELECTRICAL TEST DATA. HOLD FOR APPROVAL TO PROCEED DATE SENT: <u>9/10/18</u>				9/20/18	GA TANDEX 5

ESD MAT DUE DATE:
8/17/18

ESD MAT DUE DATE:
9/12/18

ESD MAT DUE DATE:
8/27/18

TANDEX TEST LABS
 BURN - IN MONITOR SHEET

PAGE 1 OF 1

JOB NUMBER DDS-101-13-A

TEMPERATURE TA = +125°C MIN

PART NUMBER 54HCT04

TEMP. METER# 31368

DATE CODE 1810 LOT #80393 WF48

VOLTAGE VCC = +5VDC

BURN-IN TIME 240 hrs Min

VOLT METER# 31223

ΘJC= N/A

POWER SUPPLY# 31651

BOARD# 31250

OVEN# 21

DATE	TIME	VOLTAGE	CURRENT	TEMP.	INITIAL	COMMENTS
8/30/18	6:00AM	VCC = +5VDC	ICC = .01A	125.8°C	CM	
8/31/18	5:30AM	VCC = +5VDC	ICC = 0A	126.3°C	CM	
9/3/18	NO	DATA	TAKEN			
9/4/18	6:00AM	VCC = +5VDC	ICC = 0A	126.8°C	CM	
9/5/18	7:30AM	VCC = +5VDC	ICC = .01A	125.5°C	CM	
9/6/18	10:00AM	VCC = +5VDC	ICC = .01A	126.0°C	CM	
9/7/18	5:50AM	VCC = +5VDC	ICC = .01A	126.6°C	CM	
9/10/18	6:00AM	VCC = +5VDC	ICC = .01A	126.7°C	CM	

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PROCESS FLOW CHART

FLOW NUMBER: DDS-101-13-A REV. 0

CUSTOMER: DIE DEVICES P.O. NUMBER: SS139
 PART NUMBER: 54HCT04 P/N AS RECEIVED: 54HCT04
 PART TYPE: CMOS LOGIC MICROCIRCUIT DRAWING: MIL-PRF-38534 CL K, MIL-STD-883
 DUE DATE: 7/12/18 JOB NUMBER: DDS-101-13-A
 LDC AS RECEIVED: 1810 LOT# 80393 WF48 QUANTITY RECEIVED: 30 (DIE)
 QUOTE NUMBER: DDS14267-1 MFG: SILICON SUPPLIES QUANTITY REQUIRED: 10/5/8

CAUTION: ESD REFER TO TTL DRAWING #P1025

SEQ	PROC	REF #	DESCRIPTION	QTY	REJ	ACCEPT	DATE	INSP.
16	SSL		PERFORM STEADY STATE LIFE TEST PER MIL-PRF-38534 AND MIL-STD 883 METHOD 1005. TA = 125°C (min) T = 1000 HRS (min) DATE IN: 9/26/18 TIME IN: 6:00AM DATE OUT: 11/7/18 TIME OUT: 5:30AM BURN-IN BOARD # / DESC: <u>31250</u> BURN-IN OVEN #: <u>21</u>	12	0	12		TTL 13
ESD MAT DUE DATE: <u>11/27/18</u>								
17	ELEC		PERFORM POST STEADY STATE LIFE ELECTRICAL VERIFICATION PER MFG DATA SHEET AND MIL-PRF-38534 C.3.3.4.3. @ AMBIENT, HIGH AND LOW OPERATING TEMPERATURE. READ AND RECORD. STATIC AND FUNCTIONAL TESTS +25°C 12 -55°C 12 +125°C 12 TEST +25°C WITHIN 96 HOURS EQUIPMENT USED: <u>Sentry 21</u> ASSET#: <u>30340</u> TEST FIXTURE: <u>1377/1201</u> SOFTWARE ID: <u>HCT04</u> REV: _____	12	0	12	11/8/18	TTL 6
ESD MAT DUE DATE: <u>11/27/18</u>								
18	DBP		PERFORM WIRE BOND PULL PER MIL-STD-883 METHOD 2011, & MIL-PRF-38534 C.3.3.3, C3.3.5. TEN (10) WIRES, *DO NOT USE ELECTRICAL TEST SAMPLES* EQUIPMENT USED: <u>DAGE</u> ASSET #: <u>30705</u>	5	0	5	8/14/18	#14 TTL 5
19	SEM		PULLED 8 DEVICES AT SEQ. 05 AND TRANSFERRED TO: DDS-101-13-W	8	0	8	11/12/18	TTL 5

TANDEX TEST LABS
 BURN - IN MONITOR SHEET

PAGE 1 OF 4

JOB NUMBER DDS-101-13-A

TEMPERATURE TA = +125°C Min

PART NUMBER 54 HCT04

TEMP. METER # 31368

DATE CODE 1810 LOT # 80393 WF48

VOLTAGE VCC = +5VDC

BURN-IN TIME 1000 hrs

VOLT METER# 31223

θJC = N/A

POWER SUPPLY# 31652

BOARD# 31250

OVEN# 21

DATE	TIME	VOLTAGE	CURRENT	TEMP.	INITIAL	COMMENTS
9/26/18	6:00AM	VCC = +5VDC	ICC = .01A	126.3°C	CM	
9/27/18	6:30AM	VCC = +5VDC	ICC = .01A	126.7°C	CM	
9/28/18	6:50AM	VCC = +5VDC	ICC = .01A	127.2°C	CM	
10/1/18	6:00AM	VCC = +5VDC	ICC = .01A	127.7°C	CM	
10/2/18	8:40AM	VCC = +5VDC	ICC = .01A	126.6°C	CM	
10/3/18	7:30AM	VCC = +5VDC	ICC = .01A	127.4°C	CM	
10/4/18	7:00AM	VCC = +5VDC	ICC = .01A	125.5°C	CM	
10/5/18	6:00AM	VCC = +5VDC	ICC = .01A	127.6°C	CM	
10/8/18	5:30AM	VCC = +5VDC	ICC = .01A	127.1°C	CM	

TANDEX TEST LABS
 BURN - IN MONITOR SHEET

JOB NUMBER DDS-101-13-A

TEMPERATURE TA = +125°C Min

PART NUMBER 54 HCT04

TEMP. METER # 31368

DATE CODE 1810 LOT # 80393 WF48

VOLTAGE VCC = +5VDC

BURN-IN TIME 1000 hrs

VOLT METER# 31223

ΘJC = N/A

POWER SUPPLY# 31652

BOARD# 31250

OVEN# 21

DATE	TIME	VOLTAGE	CURRENT	TEMP.	INITIAL	COMMENTS
10/9/18	NO	DATA	TAKEN			
10/10/18	6:00AM	VCC = +5VDC	ICC = .01A	126.8°C	CM	
10/11/18	5:30AM	VCC = +5VDC	ICC = .01A	127.4°C	CM	
10/12/18	5:10AM	VCC = +5VDC	ICC = .01A	126.4°C	CM	
10/15/18	8:10AM	VCC = +5VDC	ICC = .01A	127.0°C	CM	
10/16/18	7:20AM	VCC = +5VDC	ICC = .01A	126.5°C	CM	
10/17/18	12:50PM	VCC = +5VDC	ICC = .01A	127.1°C	CM	
10/18/18	12:35AM	VCC = +5VDC	ICC = .01A	126.6°C	CM	
10/19/18	9:45AM	VCC = +5VDC	ICC = .01A	126.1°C	CM	

TANDEX TEST LABS
 BURN - IN MONITOR SHEET

JOB NUMBER DDS-101-13-A

TEMPERATURE TA = +125°C Min

PART NUMBER 54 HCT04

TEMP. METER # 31368

DATE CODE 1810 LOT # 80393 WF48

VOLTAGE VCC = +5VDC

BURN-IN TIME 1000 hrs

VOLT METER# 31223

ΘJC = N/A

POWER SUPPLY# 31652

BOARD# 31250

OVEN# 21

DATE	TIME	VOLTAGE	CURRENT	TEMP.	INITIAL	COMMENTS
10/22/18	10:40 AM	VCC = +5VDC	ICC = .01A	127.2°C	CM	
10/23/18	6:30 AM	VCC = +5VDC	ICC = .01A	126.9°C	CM	
10/24/18	7:15 AM	VCC = +5VDC	ICC = .01A	126.8°C	CM	
10/25/18	6:00 AM	VCC = +5VDC	ICC = .01A	126.6°C	CM	
10/26/18	5:35 AM	VCC = +5VDC	ICC = .01A	127.0°C	CM	
10/29/18	5:45 AM	VCC = +5VDC	ICC = .01A	127.8°C	CM	
10/30/18	5:35 AM	VCC = +5VDC	ICC = .01A	127.4°C	CM	
10/31/18	5:30 AM	VCC = +5VDC	ICC = .01A	127.0°C	CM	
11/1/18	5:45 AM	VCC = +5VDC	ICC = .01A	126.5°C	CM	

TANDEX TEST LABS
 BURN - IN MONITOR SHEET

JOB NUMBER DDS-101-13-A

TEMPERATURE TA = +125°C Min

PART NUMBER 54 HCT04

TEMP. METER # 31368

DATE CODE 1810 LOT # 80393 WF48

VOLTAGE VCC = +5VDC

BURN-IN TIME 1000 hrs

VOLT METER# 31223

θJC = N/A

POWER SUPPLY# 31652

BOARD# 31250

OVEN# 21

DATE	TIME	VOLTAGE	CURRENT	TEMP.	INITIAL	COMMENTS
11/2/18	8:00 AM	VCC = +5VDC	I _{CC} = .01A	127.5°C	CM	
11/5/18	5:35 AM	VCC = +5VDC	I _{CC} = .01A	127.4°C	CM	
11/6/18	NO	DATA	TAKEN			
11/7/18	5:30 AM	VCC = +5VDC	I _{CC} = .01A	126.9°C	CM	

TANDEX TEST LABS TTL# DDS-101-13-A
BOND PULL
BOND STRENGTH TESTING

TTL Job No. DDS-101-13-A	Part Number 54HCT04	Part Type CMOS LOGIC MICROCIRCUIT	Date August 14, 2018
Lot Date Code LOT# 80393 W# 48 1810	Sample Qty. 5	Serial Numbers 11-15	Test Specifications Mil-Std-883 Method 2011
Misc.	Qty Accept 5	Qty Reject 0	Suspect 0

WIRE TYPE Au	PACKAGE/POST Au	BOND TYPE BALL BOND
DIE METALIZATION Al	WIRE SIZE 0.001	MINIMUM PULL STRENGTH 2.5gm

S/N 11			S/N 12			S/N 13			S/N 14			S/N 15			S/N		
WIRE NO	FORCE	CODE	WIRE NO	FORCE	CODE	WIRE NO	FORCE	CODE	WIRE NO	FORCE	CODE	WIRE NO	FORCE	CODE	WIRE NO	FORCE	CODE
1	4.5	G	1	5.0	G	1	5.0	G	1	5.0	G	1	5.5	G	1		
2	5.0	G	2	3.5	G	2	5.5	H	2	5.0	G	2	5.5	G	2		
3			3			3			3			3			3		
4			4			4			4			4			4		
5			5			5			5			5			5		

CODE INDEX

- A. NO BREAKS UP TO _____gms.
- B. BOND LIFTS FROM DIE.
- C. BOND LIFTS FROM POST.
- D. WIRE BREAKS AT SUBSTRATE/HEAL.
- E. BOND REMOVES UNDERLYING METALLIZATION.
- F. NO CONNECTION.
- G. WIRE BREAKS AT DIE/HEAL.
- H. WIRE BREAKS AT POST/HEAL.
- J. WIRE BREAKS AT SPAN.
- X. BOND DAMAGE PRIOR TO TESTING.



TECHNICIAN STAMP: _____

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TANDEX TEST LABS INC.

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PROCESS FLOW CHART

FLOW NUMBER: DDS-101-13-A REV. 0

CUSTOMER: DIE DEVICES P.O. NUMBER: SS139
 PART NUMBER: 54HCT04 P/N AS RECEIVED: 54HCT04
 PART TYPE: CMOS LOGIC MICROCIRCUIT DRAWING: MIL-PRF-38534 CL K, MIL-STD-883
 DUE DATE: 7/12/18 JOB NUMBER: DDS-101-13-A
 LDC AS RECEIVED: 1810 LOT# 80393 WF48 QUANTITY RECEIVED: 30 (DIE)
 QUOTE NUMBER: DDS14267-1 MFG: SILICON SUPPLIES QUANTITY REQUIRED: 10/5/8

CAUTION: ESD REFER TO TTL DRAWING #P1025

SEQ	PROC	REF #	DESCRIPTION	QTY	REJ	ACCEPT	DATE	INSP.
20	QCI	P-1073	TANDEX QUALITY CONTROL INSPECTION. QCI TO VERIFY CAR IN SEQ. 01 IS COMPLIANT	17	Ø	17	11/12/18	QA TANDEX 5
21	PKG		USE ORIGINAL OR TANDEX PACKAGING.	17	Ø	17	11/12/18	QA TANDEX 5
22	QAR	P-1213	TANDEX QUALITY ASSURANCE REVIEW. SHIP VIA: SHIP / BILL TO: DIE DEVICES 47 WHERRY ROAD NORWICH, NRI, IWS UNITED KINGDOM VAT GB#114 3513 56 * INCLUDES 10 ACCEPT 5 BOND PULL 2 SPARES ** 8 TRANSFERRED TO DDS-101-13-A FOR SEMT	* 17			11/12/18	QA TANDEX 5



MIL-PRF-38534 CLASS K DATAPACK

Pre Burn-In Test Results at -55°C



STAT1 08/20/11 09:52
TEST PROGRAM HCT04 S/N 1
DDS-101-13-A PN 54HCT04 TEST SEQ12 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-680.0MV	-1.500 V	-100.0MV
57	3	-680.0MV	-1.500 V	-100.0MV
57	5	-680.0MV	-1.500 V	-100.0MV
57	9	-680.0MV	-1.500 V	-100.0MV
57	11	-680.0MV	-1.500 V	-100.0MV
57	13	-680.0MV	-1.500 V	-100.0MV
57	14	-560.0MV	-1.500 V	-100.0MV
67	2	600.0MV	100.0MV	1.500 V
67	4	600.0MV	100.0MV	1.500 V
67	6	600.0MV	100.0MV	1.500 V
67	8	610.0MV	100.0MV	1.500 V
67	10	600.0MV	100.0MV	1.500 V
67	12	610.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.300 V	3.980 V	
218	4	4.300 V	3.980 V	
224	6	4.310 V	3.980 V	
230	8	4.280 V	3.980 V	
236	10	4.300 V	3.980 V	
242	12	4.320 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV
275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV

287	10	-6.000MV	100.0MV
293	12	-6.000MV	100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	86.00MV		260.0MV
322	4	74.00MV		260.0MV
328	6	66.00MV		260.0MV
334	8	116.0MV		260.0MV
340	10	76.00MV		260.0MV
346	12	62.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	0 V		100.0MV
275	6	0 V		100.0MV
281	8	0 V		100.0MV
287	10	0 V		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	1.000NA	-100.0NA	100.0NA
387	3	-51.00NA	-100.0NA	100.0NA
390	3	-11.00NA	-100.0NA	100.0NA
395	5	-9.000NA	-100.0NA	100.0NA
398	5	-4.000NA	-100.0NA	100.0NA
403	9	-6.000NA	-100.0NA	100.0NA
406	9	-3.000NA	-100.0NA	100.0NA
411	11	-5.000NA	-100.0NA	100.0NA
414	11	0 A	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA

422 13 0 A -100.0NA 100.0NA

ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	4.000NA		1.000UA
458	14	1.000NA		1.000UA

ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	730.0UA		2.900MA
500	14	700.0UA		2.900MA
500	14	690.0UA		2.900MA
500	14	680.0UA		2.900MA
500	14	690.0UA		2.900MA
500	14	720.0UA		2.900MA

EIR 1.....10 FCT DCT
0000000000 PASS PASS EOT

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TEST PROGRAM HCT04 S/N 2

DDS-101-13-A PN 54HCT04 TEST SEQ12 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-670.0MV	-1.500 V	-100.0MV
57	3	-670.0MV	-1.500 V	-100.0MV
57	5	-670.0MV	-1.500 V	-100.0MV
57	9	-670.0MV	-1.500 V	-100.0MV
57	11	-680.0MV	-1.500 V	-100.0MV
57	13	-680.0MV	-1.500 V	-100.0MV
57	14	-550.0MV	-1.500 V	-100.0MV
67	2	600.0MV	100.0MV	1.500 V
67	4	600.0MV	100.0MV	1.500 V
67	6	600.0MV	100.0MV	1.500 V
67	8	600.0MV	100.0MV	1.500 V
67	10	600.0MV	100.0MV	1.500 V
67	12	600.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.270 V	3.980 V	
218	4	4.300 V	3.980 V	
224	6	4.310 V	3.980 V	
230	8	4.300 V	3.980 V	
236	10	4.300 V	3.980 V	
242	12	4.320 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV	100.0MV
281	8	-6.000MV	100.0MV
287	10	-6.000MV	100.0MV
293	12	-6.000MV	100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	110.0MV		260.0MV
322	4	72.00MV		260.0MV
328	6	66.00MV		260.0MV
334	8	76.00MV		260.0MV
340	10	74.00MV		260.0MV
346	12	60.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	2.000MV		100.0MV
269	4	2.000MV		100.0MV
275	6	0 V		100.0MV
281	8	0 V		100.0MV
287	10	0 V		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	1.000NA	-100.0NA	100.0NA
387	3	-51.00NA	-100.0NA	100.0NA
390	3	-11.00NA	-100.0NA	100.0NA
395	5	-9.000NA	-100.0NA	100.0NA
398	5	-4.000NA	-100.0NA	100.0NA
403	9	-10.00NA	-100.0NA	100.0NA
406	9	-3.000NA	-100.0NA	100.0NA
411	11	-5.000NA	-100.0NA	100.0NA

414	11	-2.000NA	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

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-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	16.00NA		1.000UA
458	14	0 A		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	750.0UA		2.900MA
500	14	700.0UA		2.900MA
500	14	690.0UA		2.900MA
500	14	680.0UA		2.900MA
500	14	690.0UA		2.900MA
500	14	740.0UA		2.900MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

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TEST PROGRAM HCT04 S/N 3

DDS-101-13-A PN 54HCT04 TEST SEQ12 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-680.0MV	-1.500 V	-100.0MV
57	3	-680.0MV	-1.500 V	-100.0MV
57	5	-690.0MV	-1.500 V	-100.0MV
57	9	-690.0MV	-1.500 V	-100.0MV
57	11	-690.0MV	-1.500 V	-100.0MV
57	13	-690.0MV	-1.500 V	-100.0MV
57	14	-570.0MV	-1.500 V	-100.0MV
67	2	610.0MV	100.0MV	1.500 V
67	4	610.0MV	100.0MV	1.500 V
67	6	610.0MV	100.0MV	1.500 V
67	8	610.0MV	100.0MV	1.500 V
67	10	610.0MV	100.0MV	1.500 V
67	12	620.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.980 V	
218	4	4.300 V	3.980 V	
224	6	4.310 V	3.980 V	
230	8	4.250 V	3.980 V	
236	10	4.300 V	3.980 V	
242	12	4.320 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-8.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	120.0MV		260.0MV
322	4	80.00MV		260.0MV
328	6	66.00MV		260.0MV
334	8	128.0MV		260.0MV
340	10	74.00MV		260.0MV
346	12	62.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	0 V		100.0MV
275	6	0 V		100.0MV
281	8	0 V		100.0MV
287	10	0 V		100.0MV
293	12	-2.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	1.000NA	-100.0NA	100.0NA
387	3	-51.00NA	-100.0NA	100.0NA
390	3	-11.00NA	-100.0NA	100.0NA
395	5	-9.000NA	-100.0NA	100.0NA
398	5	-4.000NA	-100.0NA	100.0NA
403	9	-15.00NA	-100.0NA	100.0NA
406	9	0 A	-100.0NA	100.0NA
411	11	-5.000NA	-100.0NA	100.0NA

414	11	-2.000NA	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

 ICC TEST
 VCC= 6
 ICC LIMIT MAX. 1.0UA @25C/-55C
 ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	30.00NA		1.000UA
458	14	1.000NA		1.000UA

 ICC - DELTA TEST
 VCC= 5.5
 ICC LIMIT MAX. 2.4MA @25C/+125C
 ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	680.0UA		2.900MA
500	14	660.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	630.0UA		2.900MA
500	14	620.0UA		2.900MA
500	14	660.0UA		2.900MA

EIR 1.....10	FCT	DCT	
0000000000	PASS	PASS	EOT

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TEST PROGRAM HCT04 S/N 4

DDS-101-13-A PN 54HCT04 TEST SEQ12 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-670.0MV	-1.500 V	-100.0MV
57	3	-670.0MV	-1.500 V	-100.0MV
57	5	-670.0MV	-1.500 V	-100.0MV
57	9	-670.0MV	-1.500 V	-100.0MV
57	11	-680.0MV	-1.500 V	-100.0MV
57	13	-680.0MV	-1.500 V	-100.0MV
57	14	-560.0MV	-1.500 V	-100.0MV
67	2	590.0MV	100.0MV	1.500 V
67	4	600.0MV	100.0MV	1.500 V
67	6	600.0MV	100.0MV	1.500 V
67	8	600.0MV	100.0MV	1.500 V
67	10	600.0MV	100.0MV	1.500 V
67	12	600.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.270 V	3.980 V	
218	4	4.300 V	3.980 V	
224	6	4.320 V	3.980 V	
230	8	4.290 V	3.980 V	
236	10	4.300 V	3.980 V	
242	12	4.320 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-8.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-8.000MV		100.0MV
281	8	-8.000MV		100.0MV
287	10	-8.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	114.0MV		260.0MV
322	4	76.00MV		260.0MV
328	6	64.00MV		260.0MV
334	8	80.00MV		260.0MV
340	10	72.00MV		260.0MV
346	12	58.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	-2.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-2.000MV		100.0MV
287	10	-2.000MV		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	1.000NA	-100.0NA	100.0NA
387	3	-51.00NA	-100.0NA	100.0NA
390	3	-11.00NA	-100.0NA	100.0NA
395	5	-9.000NA	-100.0NA	100.0NA
398	5	-4.000NA	-100.0NA	100.0NA
403	9	-12.00NA	-100.0NA	100.0NA
406	9	0 A	-100.0NA	100.0NA
411	11	-5.000NA	-100.0NA	100.0NA

414	11	-2.000NA	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	13.00NA		1.000UA
458	14	1.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	710.0UA		2.900MA
500	14	700.0UA		2.900MA
500	14	680.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	710.0UA		2.900MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 08/20/11 09:52
TEST PROGRAM HCT04 S/N 5

DDS-101-13-A PN 54HCT04 TEST SEQ12 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-680.0MV	-1.500 V	-100.0MV
57	3	-680.0MV	-1.500 V	-100.0MV
57	5	-680.0MV	-1.500 V	-100.0MV
57	9	-680.0MV	-1.500 V	-100.0MV
57	11	-690.0MV	-1.500 V	-100.0MV
57	13	-690.0MV	-1.500 V	-100.0MV
57	14	-560.0MV	-1.500 V	-100.0MV
67	2	600.0MV	100.0MV	1.500 V
67	4	600.0MV	100.0MV	1.500 V
67	6	610.0MV	100.0MV	1.500 V
67	8	610.0MV	100.0MV	1.500 V
67	10	610.0MV	100.0MV	1.500 V
67	12	610.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.300 V	3.980 V	
218	4	4.300 V	3.980 V	
224	6	4.310 V	3.980 V	
230	8	4.290 V	3.980 V	
236	10	4.300 V	3.980 V	
242	12	4.320 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-8.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-8.000MV		100.0MV
287	10	-8.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	84.00MV		260.0MV
322	4	74.00MV		260.0MV
328	6	70.00MV		260.0MV
334	8	80.00MV		260.0MV
340	10	76.00MV		260.0MV
346	12	62.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	2.000MV		100.0MV
269	4	2.000MV		100.0MV
275	6	0 V		100.0MV
281	8	0 V		100.0MV
287	10	2.000MV		100.0MV
293	12	2.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	1.000NA	-100.0NA	100.0NA
387	3	-51.00NA	-100.0NA	100.0NA
390	3	-11.00NA	-100.0NA	100.0NA
395	5	-9.000NA	-100.0NA	100.0NA
398	5	-4.000NA	-100.0NA	100.0NA
403	9	-11.00NA	-100.0NA	100.0NA
406	9	-2.000NA	-100.0NA	100.0NA
411	11	-5.000NA	-100.0NA	100.0NA

414	11	-2.000NA	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	14.00NA		1.000UA
458	14	0 A		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	710.0UA		2.900MA
500	14	690.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	630.0UA		2.900MA
500	14	630.0UA		2.900MA
500	14	670.0UA		2.900MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 08/20/11 09:52
TEST PROGRAM HCT04 S/N 6

DDS-101-13-A PN 54HCT04 TEST SEQ12 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-680.0MV	-1.500 V	-100.0MV
57	3	-680.0MV	-1.500 V	-100.0MV
57	5	-680.0MV	-1.500 V	-100.0MV
57	9	-680.0MV	-1.500 V	-100.0MV
57	11	-680.0MV	-1.500 V	-100.0MV
57	13	-690.0MV	-1.500 V	-100.0MV
57	14	-560.0MV	-1.500 V	-100.0MV
67	2	600.0MV	100.0MV	1.500 V
67	4	600.0MV	100.0MV	1.500 V
67	6	600.0MV	100.0MV	1.500 V
67	8	610.0MV	100.0MV	1.500 V
67	10	600.0MV	100.0MV	1.500 V
67	12	600.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.290 V	3.980 V	
218	4	4.300 V	3.980 V	
224	6	4.310 V	3.980 V	
230	8	4.250 V	3.980 V	
236	10	4.300 V	3.980 V	
242	12	4.320 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-8.000MV		100.0MV
269	4	-4.000MV		100.0MV

275	6	-6.000MV	100.0MV
281	8	-4.000MV	100.0MV
287	10	-6.000MV	100.0MV
293	12	-6.000MV	100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	88.00MV		260.0MV
322	4	80.00MV		260.0MV
328	6	70.00MV		260.0MV
334	8	124.0MV		260.0MV
340	10	78.00MV		260.0MV
346	12	66.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	0 V		100.0MV
275	6	0 V		100.0MV
281	8	0 V		100.0MV
287	10	0 V		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	1.000NA	-100.0NA	100.0NA
387	3	-51.00NA	-100.0NA	100.0NA
390	3	-11.00NA	-100.0NA	100.0NA
395	5	-9.000NA	-100.0NA	100.0NA
398	5	-4.000NA	-100.0NA	100.0NA
403	9	-8.000NA	-100.0NA	100.0NA
406	9	-2.000NA	-100.0NA	100.0NA
411	11	-5.000NA	-100.0NA	100.0NA

414	11	-2.000NA	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	9.000NA		1.000UA
458	14	1.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	710.0UA		2.900MA
500	14	690.0UA		2.900MA
500	14	690.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	700.0UA		2.900MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 08/20/11 09:52
TEST PROGRAM HCT04 S/N 7

DDS-101-13-A PN 54HCT04 TEST SEQ12 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-670.0MV	-1.500 V	-100.0MV
57	3	-670.0MV	-1.500 V	-100.0MV
57	5	-670.0MV	-1.500 V	-100.0MV
57	9	-670.0MV	-1.500 V	-100.0MV
57	11	-680.0MV	-1.500 V	-100.0MV
57	13	-680.0MV	-1.500 V	-100.0MV
57	14	-550.0MV	-1.500 V	-100.0MV
67	2	600.0MV	100.0MV	1.500 V
67	4	600.0MV	100.0MV	1.500 V
67	6	600.0MV	100.0MV	1.500 V
67	8	600.0MV	100.0MV	1.500 V
67	10	610.0MV	100.0MV	1.500 V
67	12	610.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.300 V	3.980 V	
218	4	4.310 V	3.980 V	
224	6	4.310 V	3.980 V	
230	8	4.300 V	3.980 V	
236	10	4.300 V	3.980 V	
242	12	4.320 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV	100.0MV
281	8	-6.000MV	100.0MV
287	10	-6.000MV	100.0MV
293	12	-8.000MV	100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	84.00MV		260.0MV
322	4	68.00MV		260.0MV
328	6	64.00MV		260.0MV
334	8	82.00MV		260.0MV
340	10	74.00MV		260.0MV
346	12	58.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	0 V		100.0MV
275	6	-2.000MV		100.0MV
281	8	-2.000MV		100.0MV
287	10	-2.000MV		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	1.000NA	-100.0NA	100.0NA
387	3	-51.00NA	-100.0NA	100.0NA
390	3	-11.00NA	-100.0NA	100.0NA
395	5	-9.000NA	-100.0NA	100.0NA
398	5	-4.000NA	-100.0NA	100.0NA
403	9	-17.00NA	-100.0NA	100.0NA
406	9	1.000NA	-100.0NA	100.0NA
411	11	-5.000NA	-100.0NA	100.0NA

414	11	0 A	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	48.00NA		1.000UA
458	14	1.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	740.0UA		2.900MA
500	14	720.0UA		2.900MA
500	14	720.0UA		2.900MA
500	14	660.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	700.0UA		2.900MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 08/20/11 09:52
TEST PROGRAM HCT04 S/N 8

DDS-101-13-A PN 54HCT04 TEST SEQ12 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-670.0MV	-1.500 V	-100.0MV
57	3	-670.0MV	-1.500 V	-100.0MV
57	5	-670.0MV	-1.500 V	-100.0MV
57	9	-680.0MV	-1.500 V	-100.0MV
57	11	-680.0MV	-1.500 V	-100.0MV
57	13	-680.0MV	-1.500 V	-100.0MV
57	14	-560.0MV	-1.500 V	-100.0MV
67	2	600.0MV	100.0MV	1.500 V
67	4	600.0MV	100.0MV	1.500 V
67	6	600.0MV	100.0MV	1.500 V
67	8	610.0MV	100.0MV	1.500 V
67	10	610.0MV	100.0MV	1.500 V
67	12	610.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.300 V	3.980 V	
218	4	4.300 V	3.980 V	
224	6	4.310 V	3.980 V	
230	8	4.270 V	3.980 V	
236	10	4.300 V	3.980 V	
242	12	4.320 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-8.000MV		100.0MV

275	6	-8.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-8.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	86.00MV		260.0MV
322	4	68.00MV		260.0MV
328	6	64.00MV		260.0MV
334	8	156.0MV		260.0MV
340	10	74.00MV		260.0MV
346	12	60.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	0 V		100.0MV
275	6	-2.000MV		100.0MV
281	8	-2.000MV		100.0MV
287	10	-2.000MV		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	1.000NA	-100.0NA	100.0NA
387	3	-51.00NA	-100.0NA	100.0NA
390	3	-10.00NA	-100.0NA	100.0NA
395	5	-16.00NA	-100.0NA	100.0NA
398	5	3.000NA	-100.0NA	100.0NA
403	9	-36.00NA	-100.0NA	100.0NA
406	9	3.000NA	-100.0NA	100.0NA
411	11	-6.000NA	-100.0NA	100.0NA

414	11	-2.000NA	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	109.0NA		1.000UA
458	14	0 A		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	700.0UA		2.900MA
500	14	680.0UA		2.900MA
500	14	680.0UA		2.900MA
500	14	640.0UA		2.900MA
500	14	650.0UA		2.900MA
500	14	690.0UA		2.900MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```


STAT1 08/20/11 09:52
TEST PROGRAM HCT04 S/N 9

DDS-101-13-A PN 54HCT04 TEST SEQ12 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-670.0MV	-1.500 V	-100.0MV
57	3	-670.0MV	-1.500 V	-100.0MV
57	5	-680.0MV	-1.500 V	-100.0MV
57	9	-680.0MV	-1.500 V	-100.0MV
57	11	-680.0MV	-1.500 V	-100.0MV
57	13	-680.0MV	-1.500 V	-100.0MV
57	14	-560.0MV	-1.500 V	-100.0MV
67	2	600.0MV	100.0MV	1.500 V
67	4	600.0MV	100.0MV	1.500 V
67	6	600.0MV	100.0MV	1.500 V
67	8	610.0MV	100.0MV	1.500 V
67	10	610.0MV	100.0MV	1.500 V
67	12	610.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.300 V	3.980 V	
218	4	4.310 V	3.980 V	
224	6	4.320 V	3.980 V	
230	8	4.270 V	3.980 V	
236	10	4.300 V	3.980 V	
242	12	4.310 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-8.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-8.000MV		100.0MV
281	8	-8.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-8.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	82.00MV		260.0MV
322	4	68.00MV		260.0MV
328	6	64.00MV		260.0MV
334	8	104.0MV		260.0MV
340	10	72.00MV		260.0MV
346	12	60.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	-2.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-2.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	1.000NA	-100.0NA	100.0NA
387	3	-51.00NA	-100.0NA	100.0NA
390	3	-11.00NA	-100.0NA	100.0NA
395	5	-11.00NA	-100.0NA	100.0NA
398	5	1.000NA	-100.0NA	100.0NA
403	9	-24.00NA	-100.0NA	100.0NA
406	9	1.000NA	-100.0NA	100.0NA
411	11	-5.000NA	-100.0NA	100.0NA

414	11	0 A	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	52.00NA		1.000UA
458	14	1.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	660.0UA		2.900MA
500	14	640.0UA		2.900MA
500	14	630.0UA		2.900MA
500	14	600.0UA		2.900MA
500	14	600.0UA		2.900MA
500	14	630.0UA		2.900MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 08/20/11 09:52
TEST PROGRAM HCT04 S/N 10

DDS-101-13-A PN 54HCT04 TEST SEQ12 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-670.0MV	-1.500 V	-100.0MV
57	3	-670.0MV	-1.500 V	-100.0MV
57	5	-680.0MV	-1.500 V	-100.0MV
57	9	-680.0MV	-1.500 V	-100.0MV
57	11	-680.0MV	-1.500 V	-100.0MV
57	13	-680.0MV	-1.500 V	-100.0MV
57	14	-560.0MV	-1.500 V	-100.0MV
67	2	600.0MV	100.0MV	1.500 V
67	4	600.0MV	100.0MV	1.500 V
67	6	600.0MV	100.0MV	1.500 V
67	8	610.0MV	100.0MV	1.500 V
67	10	610.0MV	100.0MV	1.500 V
67	12	610.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.290 V	3.980 V	
218	4	4.310 V	3.980 V	
224	6	4.310 V	3.980 V	
230	8	4.290 V	3.980 V	
236	10	4.300 V	3.980 V	
242	12	4.310 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-8.000MV	100.0MV
281	8	-6.000MV	100.0MV
287	10	-6.000MV	100.0MV
293	12	-6.000MV	100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	86.00MV		260.0MV
322	4	68.00MV		260.0MV
328	6	66.00MV		260.0MV
334	8	92.00MV		260.0MV
340	10	74.00MV		260.0MV
346	12	62.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	0 V		100.0MV
275	6	-2.000MV		100.0MV
281	8	-2.000MV		100.0MV
287	10	-2.000MV		100.0MV
293	12	-2.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	1.000NA	-100.0NA	100.0NA
387	3	-51.00NA	-100.0NA	100.0NA
390	3	-11.00NA	-100.0NA	100.0NA
395	5	-10.00NA	-100.0NA	100.0NA
398	5	-3.000NA	-100.0NA	100.0NA
403	9	-15.00NA	-100.0NA	100.0NA
406	9	0 A	-100.0NA	100.0NA
411	11	-5.000NA	-100.0NA	100.0NA

414	11	0 A	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

 ICC TEST
 VCC= 6
 ICC LIMIT MAX. 1.0UA @25C/-55C
 ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	16.00NA		1.000UA
458	14	1.000NA		1.000UA

 ICC - DELTA TEST
 VCC= 5.5
 ICC LIMIT MAX. 2.4MA @25C/+125C
 ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	680.0UA		2.900MA
500	14	680.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	640.0UA		2.900MA
500	14	630.0UA		2.900MA
500	14	670.0UA		2.900MA

EIR 1.....10	FCT	DCT	
0000000000	PASS	PASS	EOT

STAT1 08/20/11 09:52
TEST PROGRAM HCT04 S/N 11

DDS-101-13-A PN 54HCT04 TEST SEQ12 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-670.0MV	-1.500 V	-100.0MV
57	3	-670.0MV	-1.500 V	-100.0MV
57	5	-670.0MV	-1.500 V	-100.0MV
57	9	-680.0MV	-1.500 V	-100.0MV
57	11	-680.0MV	-1.500 V	-100.0MV
57	13	-680.0MV	-1.500 V	-100.0MV
57	14	-550.0MV	-1.500 V	-100.0MV
67	2	600.0MV	100.0MV	1.500 V
67	4	600.0MV	100.0MV	1.500 V
67	6	600.0MV	100.0MV	1.500 V
67	8	600.0MV	100.0MV	1.500 V
67	10	610.0MV	100.0MV	1.500 V
67	12	610.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.300 V	3.980 V	
218	4	4.310 V	3.980 V	
224	6	4.320 V	3.980 V	
230	8	4.290 V	3.980 V	
236	10	4.310 V	3.980 V	
242	12	4.320 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV	100.0MV
281	8	-8.000MV	100.0MV
287	10	-6.000MV	100.0MV
293	12	-6.000MV	100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	82.00MV		260.0MV
322	4	66.00MV		260.0MV
328	6	64.00MV		260.0MV
334	8	242.0MV		260.0MV
340	10	70.00MV		260.0MV
346	12	58.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	0 V		100.0MV
275	6	0 V		100.0MV
281	8	0 V		100.0MV
287	10	0 V		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	1.000NA	-100.0NA	100.0NA
387	3	-52.00NA	-100.0NA	100.0NA
390	3	-9.000NA	-100.0NA	100.0NA
395	5	-12.00NA	-100.0NA	100.0NA
398	5	0 A	-100.0NA	100.0NA
403	9	-46.00NA	-100.0NA	100.0NA
406	9	5.000NA	-100.0NA	100.0NA
411	11	-5.000NA	-100.0NA	100.0NA

414	11	-2.000NA	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

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-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
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```

INST #	PIN	MEASURED	LT	GT
451	14	84.00NA		1.000UA
458	14	1.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	740.0UA		2.900MA
500	14	710.0UA		2.900MA
500	14	710.0UA		2.900MA
500	14	690.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	710.0UA		2.900MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 08/20/11 09:52
 TEST PROGRAM HCT04 S/N 12
 DDS-101-13-A PN 54HCT04 TEST SEQ12 -55C

 CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-690.0MV	-1.500 V	-100.0MV
57	3	-690.0MV	-1.500 V	-100.0MV
57	5	-690.0MV	-1.500 V	-100.0MV
57	9	-690.0MV	-1.500 V	-100.0MV
57	11	-700.0MV	-1.500 V	-100.0MV
57	13	-700.0MV	-1.500 V	-100.0MV
57	14	-580.0MV	-1.500 V	-100.0MV
67	2	620.0MV	100.0MV	1.500 V
67	4	620.0MV	100.0MV	1.500 V
67	6	620.0MV	100.0MV	1.500 V
67	8	620.0MV	100.0MV	1.500 V
67	10	620.0MV	100.0MV	1.500 V
67	12	620.0MV	100.0MV	1.500 V

 FUNCTIONAL TEST
 VCC= 4.500
 VIH= 2 VIL= 800.0E-03

 VOH1 TEST
 VCC= 4.500
 VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.460 V	4.400 V	

 VOH2 TEST
 VCC= 4.500
 VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.300 V	3.980 V	
218	4	4.310 V	3.980 V	
224	6	4.320 V	3.980 V	
230	8	4.300 V	3.980 V	
236	10	4.310 V	3.980 V	
242	12	4.320 V	3.980 V	

 VOL1 TEST
 VCC= 4.500
 VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV	100.0MV
281	8	-6.000MV	100.0MV
287	10	-6.000MV	100.0MV
293	12	-6.000MV	100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	82.00MV		260.0MV
322	4	66.00MV		260.0MV
328	6	64.00MV		260.0MV
334	8	80.00MV		260.0MV
340	10	72.00MV		260.0MV
346	12	60.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-2.000MV		100.0MV
269	4	0 V		100.0MV
275	6	-2.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-2.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	1.000NA	-100.0NA	100.0NA
387	3	-51.00NA	-100.0NA	100.0NA
390	3	-11.00NA	-100.0NA	100.0NA
395	5	-9.000NA	-100.0NA	100.0NA
398	5	-4.000NA	-100.0NA	100.0NA
403	9	-12.00NA	-100.0NA	100.0NA
406	9	1.000NA	-100.0NA	100.0NA
411	11	-5.000NA	-100.0NA	100.0NA

414	11	-2.000NA	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

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-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
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INST #	PIN	MEASURED	LT	GT
451	14	13.00NA		1.000UA
458	14	1.000NA		1.000UA

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-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	690.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	640.0UA		2.900MA
500	14	630.0UA		2.900MA
500	14	660.0UA		2.900MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```



MIL-PRF-38534 CLASS K DATAPACK

Pre Burn-In Test Results at 25°C



STAT1 08/01/11 08:19
TEST PROGRAM HCT04 S/N 1
DDS-101-13-A PN 54HCT04 TEST SEQ12 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-650.0MV	-1.500 V	-100.0MV
57	3	-650.0MV	-1.500 V	-100.0MV
57	5	-650.0MV	-1.500 V	-100.0MV
57	9	-650.0MV	-1.500 V	-100.0MV
57	11	-640.0MV	-1.500 V	-100.0MV
57	13	-650.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	550.0MV	100.0MV	1.500 V
67	4	550.0MV	100.0MV	1.500 V
67	6	550.0MV	100.0MV	1.500 V
67	8	560.0MV	100.0MV	1.500 V
67	10	550.0MV	100.0MV	1.500 V
67	12	560.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.270 V	3.980 V	
218	4	4.290 V	3.980 V	
224	6	4.290 V	3.980 V	
230	8	4.290 V	3.980 V	
236	10	4.280 V	3.980 V	
242	12	4.280 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV

287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	106.0MV		260.0MV
322	4	82.00MV		260.0MV
328	6	82.00MV		260.0MV
334	8	86.00MV		260.0MV
340	10	96.00MV		260.0MV
346	12	96.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	10.00MV		100.0MV
269	4	8.000MV		100.0MV
275	6	8.000MV		100.0MV
281	8	8.000MV		100.0MV
287	10	8.000MV		100.0MV
293	12	8.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	2.000NA	-100.0NA	100.0NA
387	3	-67.00NA	-100.0NA	100.0NA
390	3	-16.00NA	-100.0NA	100.0NA
395	5	-13.00NA	-100.0NA	100.0NA
398	5	-6.000NA	-100.0NA	100.0NA
403	9	-8.000NA	-100.0NA	100.0NA
406	9	-4.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA
414	11	-2.000NA	-100.0NA	100.0NA
419	13	-6.000NA	-100.0NA	100.0NA

422 13 0 A -100.0NA 100.0NA

ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	5.000NA		1.000UA
458	14	3.000NA		1.000UA

ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	730.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	720.0UA		2.400MA

EIR 1.....10 FCT DCT
0000000000 PASS PASS EOT

STAT1 08/01/11 08:19
TEST PROGRAM HCT04 S/N 2
DDS-101-13-A PN 54HCT04 TEST SEQ12 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-650.0MV	-1.500 V	-100.0MV
57	3	-650.0MV	-1.500 V	-100.0MV
57	5	-650.0MV	-1.500 V	-100.0MV
57	9	-650.0MV	-1.500 V	-100.0MV
57	11	-650.0MV	-1.500 V	-100.0MV
57	13	-650.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	560.0MV	100.0MV	1.500 V
67	4	560.0MV	100.0MV	1.500 V
67	6	560.0MV	100.0MV	1.500 V
67	8	560.0MV	100.0MV	1.500 V
67	10	560.0MV	100.0MV	1.500 V
67	12	560.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.270 V	3.980 V	
218	4	4.290 V	3.980 V	
224	6	4.300 V	3.980 V	
230	8	4.290 V	3.980 V	
236	10	4.280 V	3.980 V	
242	12	4.280 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV

275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-2.000MV		100.0MV
293	12	-4.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	118.0MV		260.0MV
322	4	82.00MV		260.0MV
328	6	82.00MV		260.0MV
334	8	88.00MV		260.0MV
340	10	98.00MV		260.0MV
346	12	94.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	12.00MV		100.0MV
269	4	12.00MV		100.0MV
275	6	10.00MV		100.0MV
281	8	10.00MV		100.0MV
287	10	12.00MV		100.0MV
293	12	10.00MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	2.000NA	-100.0NA	100.0NA
387	3	-69.00NA	-100.0NA	100.0NA
390	3	-16.00NA	-100.0NA	100.0NA
395	5	-13.00NA	-100.0NA	100.0NA
398	5	-6.000NA	-100.0NA	100.0NA
403	9	-8.000NA	-100.0NA	100.0NA
406	9	-4.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA

414	11	-2.000NA	-100.0NA	100.0NA
419	13	-6.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	5.000NA		1.000UA
458	14	2.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	750.0UA		2.400MA
500	14	710.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	740.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 08/01/11 08:19
TEST PROGRAM HCT04 S/N 3

DDS-101-13-A PN 54HCT04 TEST SEQ12 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-660.0MV	-1.500 V	-100.0MV
57	3	-660.0MV	-1.500 V	-100.0MV
57	5	-660.0MV	-1.500 V	-100.0MV
57	9	-650.0MV	-1.500 V	-100.0MV
57	11	-660.0MV	-1.500 V	-100.0MV
57	13	-660.0MV	-1.500 V	-100.0MV
57	14	-530.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.980 V	
218	4	4.290 V	3.980 V	
224	6	4.300 V	3.980 V	
230	8	4.290 V	3.980 V	
236	10	4.280 V	3.980 V	
242	12	4.280 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	-2.000MV		100.0MV

275	6	-4.000MV		100.0MV
281	8	-2.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-2.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	132.0MV		260.0MV
322	4	92.00MV		260.0MV
328	6	88.00MV		260.0MV
334	8	98.00MV		260.0MV
340	10	104.0MV		260.0MV
346	12	104.0MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	18.00MV		100.0MV
269	4	16.00MV		100.0MV
275	6	18.00MV		100.0MV
281	8	16.00MV		100.0MV
287	10	16.00MV		100.0MV
293	12	18.00MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	2.000NA	-100.0NA	100.0NA
387	3	-47.00NA	-100.0NA	100.0NA
390	3	-12.00NA	-100.0NA	100.0NA
395	5	-11.00NA	-100.0NA	100.0NA
398	5	-4.000NA	-100.0NA	100.0NA
403	9	-8.000NA	-100.0NA	100.0NA
406	9	-2.000NA	-100.0NA	100.0NA
411	11	-6.000NA	-100.0NA	100.0NA

414	11	0 A	-100.0NA	100.0NA
419	13	-6.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

```

-----
      ICC TEST
      VCC= 6
      ICC LIMIT MAX. 1.0UA @25C/-55C
      ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	5.000NA		1.000UA
458	14	2.000NA		1.000UA

```

-----
      ICC - DELTA TEST
      VCC= 5.5
      ICC LIMIT MAX. 2.4MA @25C/+125C
      ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	690.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	640.0UA		2.400MA
500	14	630.0UA		2.400MA
500	14	670.0UA		2.400MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS     EOT

```

STAT1 08/01/11 08:19
TEST PROGRAM HCT04 S/N 4

DDS-101-13-A PN 54HCT04 TEST SEQ12 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-660.0MV	-1.500 V	-100.0MV
57	3	-650.0MV	-1.500 V	-100.0MV
57	5	-650.0MV	-1.500 V	-100.0MV
57	9	-660.0MV	-1.500 V	-100.0MV
57	11	-650.0MV	-1.500 V	-100.0MV
57	13	-660.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	560.0MV	100.0MV	1.500 V
67	4	560.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	560.0MV	100.0MV	1.500 V
67	10	560.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.980 V	
218	4	4.290 V	3.980 V	
224	6	4.300 V	3.980 V	
230	8	4.290 V	3.980 V	
236	10	4.280 V	3.980 V	
242	12	4.280 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-4.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	124.0MV		260.0MV
322	4	82.00MV		260.0MV
328	6	82.00MV		260.0MV
334	8	86.00MV		260.0MV
340	10	96.00MV		260.0MV
346	12	94.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	10.00MV		100.0MV
269	4	10.00MV		100.0MV
275	6	8.000MV		100.0MV
281	8	8.000MV		100.0MV
287	10	8.000MV		100.0MV
293	12	10.00MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	2.000NA	-100.0NA	100.0NA
387	3	-56.00NA	-100.0NA	100.0NA
390	3	-13.00NA	-100.0NA	100.0NA
395	5	-12.00NA	-100.0NA	100.0NA
398	5	-5.000NA	-100.0NA	100.0NA
403	9	-8.000NA	-100.0NA	100.0NA
406	9	-3.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA

414	11	-2.000NA	-100.0NA	100.0NA
419	13	-6.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	5.000NA		1.000UA
458	14	3.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	720.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	710.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 08/01/11 08:19
TEST PROGRAM HCT04 S/N 5

DDS-101-13-A PN 54HCT04 TEST SEQ12 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-650.0MV	-1.500 V	-100.0MV
57	3	-650.0MV	-1.500 V	-100.0MV
57	5	-650.0MV	-1.500 V	-100.0MV
57	9	-650.0MV	-1.500 V	-100.0MV
57	11	-650.0MV	-1.500 V	-100.0MV
57	13	-650.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	560.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	560.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.270 V	3.980 V	
218	4	4.290 V	3.980 V	
224	6	4.300 V	3.980 V	
230	8	4.290 V	3.980 V	
236	10	4.280 V	3.980 V	
242	12	4.290 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-2.000MV		100.0MV
269	4	-4.000MV		100.0MV

275	6	-4.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	116.0MV		260.0MV
322	4	82.00MV		260.0MV
328	6	84.00MV		260.0MV
334	8	90.00MV		260.0MV
340	10	98.00MV		260.0MV
346	12	98.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	12.00MV		100.0MV
269	4	12.00MV		100.0MV
275	6	10.00MV		100.0MV
281	8	12.00MV		100.0MV
287	10	12.00MV		100.0MV
293	12	10.00MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	2.000NA	-100.0NA	100.0NA
387	3	-68.00NA	-100.0NA	100.0NA
390	3	-16.00NA	-100.0NA	100.0NA
395	5	-13.00NA	-100.0NA	100.0NA
398	5	-6.000NA	-100.0NA	100.0NA
403	9	-8.000NA	-100.0NA	100.0NA
406	9	-4.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA

414	11	-2.000NA	-100.0NA	100.0NA
419	13	-6.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	6.000NA		1.000UA
458	14	2.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	720.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	630.0UA		2.400MA
500	14	640.0UA		2.400MA
500	14	670.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 08/01/11 08:19
TEST PROGRAM HCT04 S/N 6

DDS-101-13-A PN 54HCT04 TEST SEQ12 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-650.0MV	-1.500 V	-100.0MV
57	3	-650.0MV	-1.500 V	-100.0MV
57	5	-650.0MV	-1.500 V	-100.0MV
57	9	-650.0MV	-1.500 V	-100.0MV
57	11	-650.0MV	-1.500 V	-100.0MV
57	13	-650.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	560.0MV	100.0MV	1.500 V
67	4	560.0MV	100.0MV	1.500 V
67	6	560.0MV	100.0MV	1.500 V
67	8	560.0MV	100.0MV	1.500 V
67	10	560.0MV	100.0MV	1.500 V
67	12	560.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.270 V	3.980 V	
218	4	4.290 V	3.980 V	
224	6	4.300 V	3.980 V	
230	8	4.290 V	3.980 V	
236	10	4.280 V	3.980 V	
242	12	4.280 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-2.000MV		100.0MV
269	4	-4.000MV		100.0MV

275	6	-4.000MV		100.0MV
281	8	-2.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-2.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	124.0MV		260.0MV
322	4	90.00MV		260.0MV
328	6	86.00MV		260.0MV
334	8	92.00MV		260.0MV
340	10	106.0MV		260.0MV
346	12	100.0MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	16.00MV		100.0MV
269	4	14.00MV		100.0MV
275	6	16.00MV		100.0MV
281	8	14.00MV		100.0MV
287	10	14.00MV		100.0MV
293	12	16.00MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	2.000NA	-100.0NA	100.0NA
387	3	-56.00NA	-100.0NA	100.0NA
390	3	-14.00NA	-100.0NA	100.0NA
395	5	-12.00NA	-100.0NA	100.0NA
398	5	-4.000NA	-100.0NA	100.0NA
403	9	-8.000NA	-100.0NA	100.0NA
406	9	-3.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA

414	11	-2.000NA	-100.0NA	100.0NA
419	13	-6.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	5.000NA		1.000UA
458	14	3.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	710.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	700.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 08/01/11 08:19
TEST PROGRAM HCT04 S/N 7

DDS-101-13-A PN 54HCT04 TEST SEQ12 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-660.0MV	-1.500 V	-100.0MV
57	3	-660.0MV	-1.500 V	-100.0MV
57	5	-660.0MV	-1.500 V	-100.0MV
57	9	-660.0MV	-1.500 V	-100.0MV
57	11	-660.0MV	-1.500 V	-100.0MV
57	13	-660.0MV	-1.500 V	-100.0MV
57	14	-530.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.270 V	3.980 V	
218	4	4.290 V	3.980 V	
224	6	4.300 V	3.980 V	
230	8	4.290 V	3.980 V	
236	10	4.290 V	3.980 V	
242	12	4.290 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-4.000MV		100.0MV

275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	112.0MV		260.0MV
322	4	78.00MV		260.0MV
328	6	76.00MV		260.0MV
334	8	84.00MV		260.0MV
340	10	92.00MV		260.0MV
346	12	92.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	8.000MV		100.0MV
269	4	8.000MV		100.0MV
275	6	8.000MV		100.0MV
281	8	8.000MV		100.0MV
287	10	8.000MV		100.0MV
293	12	10.00MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	2.000NA	-100.0NA	100.0NA
387	3	-69.00NA	-100.0NA	100.0NA
390	3	-16.00NA	-100.0NA	100.0NA
395	5	-13.00NA	-100.0NA	100.0NA
398	5	-6.000NA	-100.0NA	100.0NA
403	9	-8.000NA	-100.0NA	100.0NA
406	9	-4.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA

414	11	-2.000NA	-100.0NA	100.0NA
419	13	-6.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	5.000NA		1.000UA
458	14	2.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	740.0UA		2.400MA
500	14	720.0UA		2.400MA
500	14	720.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	710.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 08/01/11 08:19
TEST PROGRAM HCT04 S/N 8
DDS-101-13-A PN 54HCT04 TEST SEQ12 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-660.0MV	-1.500 V	-100.0MV
57	3	-660.0MV	-1.500 V	-100.0MV
57	5	-660.0MV	-1.500 V	-100.0MV
57	9	-650.0MV	-1.500 V	-100.0MV
57	11	-660.0MV	-1.500 V	-100.0MV
57	13	-660.0MV	-1.500 V	-100.0MV
57	14	-530.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.270 V	3.980 V	
218	4	4.290 V	3.980 V	
224	6	4.300 V	3.980 V	
230	8	4.270 V	3.980 V	
236	10	4.290 V	3.980 V	
242	12	4.280 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV

275	6	-6.000MV	100.0MV
281	8	-4.000MV	100.0MV
287	10	-6.000MV	100.0MV
293	12	-4.000MV	100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	116.0MV		260.0MV
322	4	80.00MV		260.0MV
328	6	78.00MV		260.0MV
334	8	106.0MV		260.0MV
340	10	88.00MV		260.0MV
346	12	92.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	8.000MV		100.0MV
269	4	8.000MV		100.0MV
275	6	6.000MV		100.0MV
281	8	8.000MV		100.0MV
287	10	6.000MV		100.0MV
293	12	8.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	2.000NA	-100.0NA	100.0NA
387	3	-68.00NA	-100.0NA	100.0NA
390	3	-16.00NA	-100.0NA	100.0NA
395	5	-13.00NA	-100.0NA	100.0NA
398	5	-6.000NA	-100.0NA	100.0NA
403	9	-8.000NA	-100.0NA	100.0NA
406	9	-3.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA

414	11	-3.000NA	-100.0NA	100.0NA
419	13	-6.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	5.000NA		1.000UA
458	14	2.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	700.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	650.0UA		2.400MA
500	14	660.0UA		2.400MA
500	14	690.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 08/01/11 08:19
 TEST PROGRAM HCT04 S/N 9
 DDS-101-13-A PN 54HCT04 TEST SEQ12 +25C

 CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-660.0MV	-1.500 V	-100.0MV
57	3	-660.0MV	-1.500 V	-100.0MV
57	5	-660.0MV	-1.500 V	-100.0MV
57	9	-660.0MV	-1.500 V	-100.0MV
57	11	-660.0MV	-1.500 V	-100.0MV
57	13	-660.0MV	-1.500 V	-100.0MV
57	14	-530.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

 FUNCTIONAL TEST
 VCC= 4.500
 VIH= 2 VIL= 800.0E-03

 VOH1 TEST
 VCC= 4.500
 VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

 VOH2 TEST
 VCC= 4.500
 VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.980 V	
218	4	4.290 V	3.980 V	
224	6	4.300 V	3.980 V	
230	8	4.260 V	3.980 V	
236	10	4.290 V	3.980 V	
242	12	4.280 V	3.980 V	

 VOL1 TEST
 VCC= 4.500
 VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV

275	6	-4.000MV	100.0MV
281	8	-6.000MV	100.0MV
287	10	-4.000MV	100.0MV
293	12	-4.000MV	100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	120.0MV		260.0MV
322	4	82.00MV		260.0MV
328	6	82.00MV		260.0MV
334	8	112.0MV		260.0MV
340	10	88.00MV		260.0MV
346	12	98.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	12.00MV		100.0MV
269	4	12.00MV		100.0MV
275	6	10.00MV		100.0MV
281	8	10.00MV		100.0MV
287	10	12.00MV		100.0MV
293	12	10.00MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	2.000NA	-100.0NA	100.0NA
387	3	-61.00NA	-100.0NA	100.0NA
390	3	-14.00NA	-100.0NA	100.0NA
395	5	-12.00NA	-100.0NA	100.0NA
398	5	-5.000NA	-100.0NA	100.0NA
403	9	-8.000NA	-100.0NA	100.0NA
406	9	-3.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA

414	11	0 A	-100.0NA	100.0NA
419	13	-6.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

 ICC TEST
 VCC= 6
 ICC LIMIT MAX. 1.0UA @25C/-55C
 ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	5.000NA		1.000UA
458	14	2.000NA		1.000UA

 ICC - DELTA TEST
 VCC= 5.5
 ICC LIMIT MAX. 2.4MA @25C/+125C
 ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	670.0UA		2.400MA
500	14	650.0UA		2.400MA
500	14	640.0UA		2.400MA
500	14	610.0UA		2.400MA
500	14	610.0UA		2.400MA
500	14	640.0UA		2.400MA

EIR 1.....10 FCT DCT
 0000000000 PASS PASS EOT

STAT1 08/01/11 08:19
TEST PROGRAM HCT04 S/N 10

DDS-101-13-A PN 54HCT04 TEST SEQ12 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-660.0MV	-1.500 V	-100.0MV
57	3	-660.0MV	-1.500 V	-100.0MV
57	5	-660.0MV	-1.500 V	-100.0MV
57	9	-660.0MV	-1.500 V	-100.0MV
57	11	-660.0MV	-1.500 V	-100.0MV
57	13	-660.0MV	-1.500 V	-100.0MV
57	14	-530.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.980 V	
218	4	4.290 V	3.980 V	
224	6	4.300 V	3.980 V	
230	8	4.290 V	3.980 V	
236	10	4.290 V	3.980 V	
242	12	4.280 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-4.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	118.0MV		260.0MV
322	4	82.00MV		260.0MV
328	6	82.00MV		260.0MV
334	8	88.00MV		260.0MV
340	10	86.00MV		260.0MV
346	12	96.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	10.00MV		100.0MV
269	4	10.00MV		100.0MV
275	6	10.00MV		100.0MV
281	8	8.000MV		100.0MV
287	10	8.000MV		100.0MV
293	12	10.00MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	2.000NA	-100.0NA	100.0NA
387	3	-52.00NA	-100.0NA	100.0NA
390	3	-13.00NA	-100.0NA	100.0NA
395	5	-11.00NA	-100.0NA	100.0NA
398	5	-4.000NA	-100.0NA	100.0NA
403	9	-8.000NA	-100.0NA	100.0NA
406	9	-3.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA

414	11	0 A	-100.0NA	100.0NA
419	13	-6.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

```

-----
      ICC TEST
      VCC= 6
      ICC LIMIT MAX. 1.0UA @25C/-55C
      ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	5.000NA		1.000UA
458	14	2.000NA		1.000UA

```

-----
      ICC - DELTA TEST
      VCC= 5.5
      ICC LIMIT MAX. 2.4MA @25C/+125C
      ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	690.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	650.0UA		2.400MA
500	14	640.0UA		2.400MA
500	14	680.0UA		2.400MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS     EOT

```

STAT1 08/01/11 08:19
TEST PROGRAM HCT04 S/N 11

DDS-101-13-A PN 54HCT04 TEST SEQ12 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-650.0MV	-1.500 V	-100.0MV
57	3	-650.0MV	-1.500 V	-100.0MV
57	5	-660.0MV	-1.500 V	-100.0MV
57	9	-650.0MV	-1.500 V	-100.0MV
57	11	-650.0MV	-1.500 V	-100.0MV
57	13	-660.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	560.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.980 V	
218	4	4.290 V	3.980 V	
224	6	4.300 V	3.980 V	
230	8	4.290 V	3.980 V	
236	10	4.290 V	3.980 V	
242	12	4.280 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	0 V		100.0MV

275	6	0 V	100.0MV
281	8	0 V	100.0MV
287	10	0 V	100.0MV
293	12	-2.000MV	100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	126.0MV		260.0MV
322	4	90.00MV		260.0MV
328	6	90.00MV		260.0MV
334	8	92.00MV		260.0MV
340	10	94.00MV		260.0MV
346	12	104.0MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	24.00MV		100.0MV
269	4	24.00MV		100.0MV
275	6	22.00MV		100.0MV
281	8	22.00MV		100.0MV
287	10	22.00MV		100.0MV
293	12	24.00MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-100.0NA	100.0NA
382	1	2.000NA	-100.0NA	100.0NA
387	3	-40.00NA	-100.0NA	100.0NA
390	3	-10.00NA	-100.0NA	100.0NA
395	5	-10.00NA	-100.0NA	100.0NA
398	5	-3.000NA	-100.0NA	100.0NA
403	9	-7.000NA	-100.0NA	100.0NA
406	9	-2.000NA	-100.0NA	100.0NA
411	11	-6.000NA	-100.0NA	100.0NA

414	11	0 A	-100.0NA	100.0NA
419	13	-6.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	6.000NA		1.000UA
458	14	2.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	750.0UA		2.400MA
500	14	720.0UA		2.400MA
500	14	710.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	710.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 08/01/11 08:19
TEST PROGRAM HCT04 S/N 12

DDS-101-13-A PN 54HCT04 TEST SEQ12 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-650.0MV	-1.500 V	-100.0MV
57	3	-650.0MV	-1.500 V	-100.0MV
57	5	-650.0MV	-1.500 V	-100.0MV
57	9	-650.0MV	-1.500 V	-100.0MV
57	11	-660.0MV	-1.500 V	-100.0MV
57	13	-660.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.980 V	
218	4	4.290 V	3.980 V	
224	6	4.290 V	3.980 V	
230	8	4.280 V	3.980 V	
236	10	4.290 V	3.980 V	
242	12	4.280 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-4.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	116.0MV		260.0MV
322	4	80.00MV		260.0MV
328	6	80.00MV		260.0MV
334	8	92.00MV		260.0MV
340	10	84.00MV		260.0MV
346	12	96.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	8.000MV		100.0MV
269	4	8.000MV		100.0MV
275	6	8.000MV		100.0MV
281	8	6.000MV		100.0MV
287	10	8.000MV		100.0MV
293	12	8.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	2.000NA	-100.0NA	100.0NA
387	3	-58.00NA	-100.0NA	100.0NA
390	3	-14.00NA	-100.0NA	100.0NA
395	5	-12.00NA	-100.0NA	100.0NA
398	5	-5.000NA	-100.0NA	100.0NA
403	9	-8.000NA	-100.0NA	100.0NA
406	9	-3.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA

414	11	-2.000NA	-100.0NA	100.0NA
419	13	-6.000NA	-100.0NA	100.0NA
422	13	0 A	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	5.000NA		1.000UA
458	14	2.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	700.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	650.0UA		2.400MA
500	14	640.0UA		2.400MA
500	14	670.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```



MIL-PRF-38534 CLASS K DATAPACK

Pre Burn-In Test Results at +125°C



STAT1 08/20/11 09:52
TEST PROGRAM HCT04 S/N 1
DDS-101-13-A PN 54HCT04 TEST SEQ12 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-640.0MV	-1.500 V	-100.0MV
57	3	-640.0MV	-1.500 V	-100.0MV
57	5	-640.0MV	-1.500 V	-100.0MV
57	9	-630.0MV	-1.500 V	-100.0MV
57	11	-630.0MV	-1.500 V	-100.0MV
57	13	-630.0MV	-1.500 V	-100.0MV
57	14	-490.0MV	-1.500 V	-100.0MV
67	2	530.0MV	100.0MV	1.500 V
67	4	530.0MV	100.0MV	1.500 V
67	6	520.0MV	100.0MV	1.500 V
67	8	520.0MV	100.0MV	1.500 V
67	10	520.0MV	100.0MV	1.500 V
67	12	520.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.270 V	3.700 V	
218	4	4.270 V	3.700 V	
224	6	4.280 V	3.700 V	
230	8	4.260 V	3.700 V	
236	10	4.270 V	3.700 V	
242	12	4.280 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-6.000MV		100.0MV
275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV

287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	114.0MV		400.0MV
322	4	98.00MV		400.0MV
328	6	94.00MV		400.0MV
334	8	112.0MV		400.0MV
340	10	102.0MV		400.0MV
346	12	92.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	2.000MV		100.0MV
269	4	0 V		100.0MV
275	6	0 V		100.0MV
281	8	2.000MV		100.0MV
287	10	2.000MV		100.0MV
293	12	2.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-1.000UA	1.000UA
382	1	1.000NA	-1.000UA	1.000UA
387	3	-6.000NA	-1.000UA	1.000UA
390	3	0 A	-1.000UA	1.000UA
395	5	-4.000NA	-1.000UA	1.000UA
398	5	1.000NA	-1.000UA	1.000UA
403	9	-4.000NA	-1.000UA	1.000UA
406	9	1.000NA	-1.000UA	1.000UA
411	11	-4.000NA	-1.000UA	1.000UA
414	11	1.000NA	-1.000UA	1.000UA
419	13	-4.000NA	-1.000UA	1.000UA

422 13 1.000NA -1.000UA 1.000UA

ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	0 A		40.00UA
458	14	100.0NA		40.00UA

ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	740.0UA		2.400MA
500	14	710.0UA		2.400MA
500	14	710.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	720.0UA		2.400MA

EIR 1.....10 FCT DCT
0000000000 PASS PASS EOT

STAT1 08/20/11 09:52
TEST PROGRAM HCT04 S/N 2

DDS-101-13-A PN 54HCT04 TEST SEQ12 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-640.0MV	-1.500 V	-100.0MV
57	3	-640.0MV	-1.500 V	-100.0MV
57	5	-640.0MV	-1.500 V	-100.0MV
57	9	-630.0MV	-1.500 V	-100.0MV
57	11	-630.0MV	-1.500 V	-100.0MV
57	13	-630.0MV	-1.500 V	-100.0MV
57	14	-490.0MV	-1.500 V	-100.0MV
67	2	540.0MV	100.0MV	1.500 V
67	4	540.0MV	100.0MV	1.500 V
67	6	530.0MV	100.0MV	1.500 V
67	8	530.0MV	100.0MV	1.500 V
67	10	530.0MV	100.0MV	1.500 V
67	12	520.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.270 V	3.700 V	
218	4	4.270 V	3.700 V	
224	6	4.280 V	3.700 V	
230	8	4.260 V	3.700 V	
236	10	4.270 V	3.700 V	
242	12	4.290 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-4.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	108.0MV		400.0MV
322	4	98.00MV		400.0MV
328	6	92.00MV		400.0MV
334	8	110.0MV		400.0MV
340	10	100.0MV		400.0MV
346	12	88.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	2.000MV		100.0MV
269	4	2.000MV		100.0MV
275	6	2.000MV		100.0MV
281	8	2.000MV		100.0MV
287	10	2.000MV		100.0MV
293	12	4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-1.000UA	1.000UA
382	1	1.000NA	-1.000UA	1.000UA
387	3	-4.000NA	-1.000UA	1.000UA
390	3	1.000NA	-1.000UA	1.000UA
395	5	-4.000NA	-1.000UA	1.000UA
398	5	1.000NA	-1.000UA	1.000UA
403	9	-4.000NA	-1.000UA	1.000UA
406	9	1.000NA	-1.000UA	1.000UA
411	11	-4.000NA	-1.000UA	1.000UA

414	11	1.000NA	-1.000UA	1.000UA
419	13	-4.000NA	-1.000UA	1.000UA
422	13	1.000NA	-1.000UA	1.000UA

 ICC TEST
 VCC= 6
 ICC LIMIT MAX. 1.0UA @25C/-55C
 ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	0 A		40.00UA
458	14	100.0NA		40.00UA

 ICC - DELTA TEST
 VCC= 5.5
 ICC LIMIT MAX. 2.4MA @25C/+125C
 ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	760.0UA		2.400MA
500	14	720.0UA		2.400MA
500	14	710.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	710.0UA		2.400MA
500	14	740.0UA		2.400MA

EIR 1.....10	FCT	DCT	
0000000000	PASS	PASS	EOT

STAT1 08/20/11 09:52
TEST PROGRAM HCT04 S/N 3

DDS-101-13-A PN 54HCT04 TEST SEQ12 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-610.0MV	-1.500 V	-100.0MV
57	3	-600.0MV	-1.500 V	-100.0MV
57	5	-600.0MV	-1.500 V	-100.0MV
57	9	-600.0MV	-1.500 V	-100.0MV
57	11	-590.0MV	-1.500 V	-100.0MV
57	13	-590.0MV	-1.500 V	-100.0MV
57	14	-450.0MV	-1.500 V	-100.0MV
67	2	500.0MV	100.0MV	1.500 V
67	4	500.0MV	100.0MV	1.500 V
67	6	500.0MV	100.0MV	1.500 V
67	8	490.0MV	100.0MV	1.500 V
67	10	490.0MV	100.0MV	1.500 V
67	12	490.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.700 V	
218	4	4.260 V	3.700 V	
224	6	4.270 V	3.700 V	
230	8	4.250 V	3.700 V	
236	10	4.260 V	3.700 V	
242	12	4.270 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-4.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-4.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	116.0MV		400.0MV
322	4	108.0MV		400.0MV
328	6	98.00MV		400.0MV
334	8	116.0MV		400.0MV
340	10	106.0MV		400.0MV
346	12	94.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	0 V		100.0MV
275	6	0 V		100.0MV
281	8	-2.000MV		100.0MV
287	10	-2.000MV		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-1.000UA	1.000UA
382	1	1.000NA	-1.000UA	1.000UA
387	3	-4.000NA	-1.000UA	1.000UA
390	3	1.000NA	-1.000UA	1.000UA
395	5	-4.000NA	-1.000UA	1.000UA
398	5	1.000NA	-1.000UA	1.000UA
403	9	-4.000NA	-1.000UA	1.000UA
406	9	1.000NA	-1.000UA	1.000UA
411	11	-4.000NA	-1.000UA	1.000UA

414	11	1.000NA	-1.000UA	1.000UA
419	13	-4.000NA	-1.000UA	1.000UA
422	13	1.000NA	-1.000UA	1.000UA

```

-----
      ICC TEST
      VCC= 6
      ICC LIMIT MAX. 1.0UA @25C/-55C
      ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	0 A		40.00UA
458	14	100.0NA		40.00UA

```

-----
      ICC - DELTA TEST
      VCC= 5.5
      ICC LIMIT MAX. 2.4MA @25C/+125C
      ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	690.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	650.0UA		2.400MA
500	14	640.0UA		2.400MA
500	14	680.0UA		2.400MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS     EOT

```

STAT1 08/20/11 09:52
 TEST PROGRAM HCT04 S/N 4
 DDS-101-13-A PN 54HCT04 TEST SEQ12 +125C

 CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-620.0MV	-1.500 V	-100.0MV
57	3	-620.0MV	-1.500 V	-100.0MV
57	5	-610.0MV	-1.500 V	-100.0MV
57	9	-610.0MV	-1.500 V	-100.0MV
57	11	-610.0MV	-1.500 V	-100.0MV
57	13	-610.0MV	-1.500 V	-100.0MV
57	14	-460.0MV	-1.500 V	-100.0MV
67	2	510.0MV	100.0MV	1.500 V
67	4	510.0MV	100.0MV	1.500 V
67	6	510.0MV	100.0MV	1.500 V
67	8	500.0MV	100.0MV	1.500 V
67	10	500.0MV	100.0MV	1.500 V
67	12	500.0MV	100.0MV	1.500 V

 FUNCTIONAL TEST
 VCC= 4.500
 VIH= 2 VIL= 800.0E-03

 VOH1 TEST
 VCC= 4.500
 VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

 VOH2 TEST
 VCC= 4.500
 VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.700 V	
218	4	4.250 V	3.700 V	
224	6	4.270 V	3.700 V	
230	8	4.250 V	3.700 V	
236	10	4.260 V	3.700 V	
242	12	4.280 V	3.700 V	

 VOL1 TEST
 VCC= 4.500
 VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-4.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-4.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	116.0MV		400.0MV
322	4	118.0MV		400.0MV
328	6	98.00MV		400.0MV
334	8	114.0MV		400.0MV
340	10	106.0MV		400.0MV
346	12	94.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	4.000MV		100.0MV
269	4	2.000MV		100.0MV
275	6	2.000MV		100.0MV
281	8	2.000MV		100.0MV
287	10	4.000MV		100.0MV
293	12	4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-1.000UA	1.000UA
382	1	1.000NA	-1.000UA	1.000UA
387	3	-4.000NA	-1.000UA	1.000UA
390	3	1.000NA	-1.000UA	1.000UA
395	5	-4.000NA	-1.000UA	1.000UA
398	5	1.000NA	-1.000UA	1.000UA
403	9	-4.000NA	-1.000UA	1.000UA
406	9	1.000NA	-1.000UA	1.000UA
411	11	-4.000NA	-1.000UA	1.000UA

414	11	1.000NA	-1.000UA	1.000UA
419	13	-4.000NA	-1.000UA	1.000UA
422	13	1.000NA	-1.000UA	1.000UA

```

-----
      ICC TEST
      VCC= 6
      ICC LIMIT MAX. 1.0UA @25C/-55C
      ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	0 A		40.00UA
458	14	200.0NA		40.00UA

```

-----
      ICC - DELTA TEST
      VCC= 5.5
      ICC LIMIT MAX. 2.4MA @25C/+125C
      ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	720.0UA		2.400MA
500	14	710.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	720.0UA		2.400MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS     EOT

```

STAT1 08/20/11 09:52
 TEST PROGRAM HCT04 S/N 5
 DDS-101-13-A PN 54HCT04 TEST SEQ12 +125C

 CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-610.0MV	-1.500 V	-100.0MV
57	3	-610.0MV	-1.500 V	-100.0MV
57	5	-600.0MV	-1.500 V	-100.0MV
57	9	-600.0MV	-1.500 V	-100.0MV
57	11	-600.0MV	-1.500 V	-100.0MV
57	13	-600.0MV	-1.500 V	-100.0MV
57	14	-450.0MV	-1.500 V	-100.0MV
67	2	500.0MV	100.0MV	1.500 V
67	4	500.0MV	100.0MV	1.500 V
67	6	500.0MV	100.0MV	1.500 V
67	8	490.0MV	100.0MV	1.500 V
67	10	490.0MV	100.0MV	1.500 V
67	12	490.0MV	100.0MV	1.500 V

 FUNCTIONAL TEST
 VCC= 4.500
 VIH= 2 VIL= 800.0E-03

 VOH1 TEST
 VCC= 4.500
 VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

 VOH2 TEST
 VCC= 4.500
 VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.700 V	
218	4	4.270 V	3.700 V	
224	6	4.270 V	3.700 V	
230	8	4.250 V	3.700 V	
236	10	4.260 V	3.700 V	
242	12	4.280 V	3.700 V	

 VOL1 TEST
 VCC= 4.500
 VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-4.000MV		100.0MV

275	6	-6.000MV	100.0MV
281	8	-6.000MV	100.0MV
287	10	-4.000MV	100.0MV
293	12	-6.000MV	100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	116.0MV		400.0MV
322	4	94.00MV		400.0MV
328	6	96.00MV		400.0MV
334	8	118.0MV		400.0MV
340	10	104.0MV		400.0MV
346	12	94.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	2.000MV		100.0MV
275	6	0 V		100.0MV
281	8	0 V		100.0MV
287	10	0 V		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-1.000UA	1.000UA
382	1	1.000NA	-1.000UA	1.000UA
387	3	-4.000NA	-1.000UA	1.000UA
390	3	1.000NA	-1.000UA	1.000UA
395	5	-4.000NA	-1.000UA	1.000UA
398	5	1.000NA	-1.000UA	1.000UA
403	9	-4.000NA	-1.000UA	1.000UA
406	9	1.000NA	-1.000UA	1.000UA
411	11	-4.000NA	-1.000UA	1.000UA

414	11	1.000NA	-1.000UA	1.000UA
419	13	-4.000NA	-1.000UA	1.000UA
422	13	1.000NA	-1.000UA	1.000UA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	100.0NA		40.00UA
458	14	200.0NA		40.00UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	720.0UA		2.400MA
500	14	710.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	640.0UA		2.400MA
500	14	650.0UA		2.400MA
500	14	680.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 08/20/11 09:52
 TEST PROGRAM HCT04 S/N 6
 DDS-101-13-A PN 54HCT04 TEST SEQ12 +125C

 CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-620.0MV	-1.500 V	-100.0MV
57	3	-620.0MV	-1.500 V	-100.0MV
57	5	-610.0MV	-1.500 V	-100.0MV
57	9	-610.0MV	-1.500 V	-100.0MV
57	11	-610.0MV	-1.500 V	-100.0MV
57	13	-610.0MV	-1.500 V	-100.0MV
57	14	-470.0MV	-1.500 V	-100.0MV
67	2	510.0MV	100.0MV	1.500 V
67	4	510.0MV	100.0MV	1.500 V
67	6	510.0MV	100.0MV	1.500 V
67	8	510.0MV	100.0MV	1.500 V
67	10	500.0MV	100.0MV	1.500 V
67	12	500.0MV	100.0MV	1.500 V

 FUNCTIONAL TEST
 VCC= 4.500
 VIH= 2 VIL= 800.0E-03

 VOH1 TEST
 VCC= 4.500
 VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

 VOH2 TEST
 VCC= 4.500
 VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.700 V	
218	4	4.280 V	3.700 V	
224	6	4.270 V	3.700 V	
230	8	4.260 V	3.700 V	
236	10	4.270 V	3.700 V	
242	12	4.280 V	3.700 V	

 VOL1 TEST
 VCC= 4.500
 VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-4.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	114.0MV		400.0MV
322	4	94.00MV		400.0MV
328	6	94.00MV		400.0MV
334	8	110.0MV		400.0MV
340	10	102.0MV		400.0MV
346	12	90.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	2.000MV		100.0MV
269	4	0 V		100.0MV
275	6	0 V		100.0MV
281	8	-4.000MV		100.0MV
287	10	-2.000MV		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-1.000UA	1.000UA
382	1	1.000NA	-1.000UA	1.000UA
387	3	-4.000NA	-1.000UA	1.000UA
390	3	1.000NA	-1.000UA	1.000UA
395	5	-4.000NA	-1.000UA	1.000UA
398	5	1.000NA	-1.000UA	1.000UA
403	9	-4.000NA	-1.000UA	1.000UA
406	9	1.000NA	-1.000UA	1.000UA
411	11	-4.000NA	-1.000UA	1.000UA

414	11	1.000NA	-1.000UA	1.000UA
419	13	-4.000NA	-1.000UA	1.000UA
422	13	1.000NA	-1.000UA	1.000UA

```

-----
      ICC TEST
      VCC= 6
      ICC LIMIT MAX. 1.0UA @25C/-55C
      ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	0 A		40.00UA
458	14	100.0NA		40.00UA

```

-----
      ICC - DELTA TEST
      VCC= 5.5
      ICC LIMIT MAX. 2.4MA @25C/+125C
      ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	720.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	700.0UA		2.400MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS     EOT

```

STAT1 08/20/11 09:52
TEST PROGRAM HCT04 S/N 7

DDS-101-13-A PN 54HCT04 TEST SEQ12 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-610.0MV	-1.500 V	-100.0MV
57	3	-610.0MV	-1.500 V	-100.0MV
57	5	-610.0MV	-1.500 V	-100.0MV
57	9	-600.0MV	-1.500 V	-100.0MV
57	11	-600.0MV	-1.500 V	-100.0MV
57	13	-600.0MV	-1.500 V	-100.0MV
57	14	-460.0MV	-1.500 V	-100.0MV
67	2	510.0MV	100.0MV	1.500 V
67	4	500.0MV	100.0MV	1.500 V
67	6	500.0MV	100.0MV	1.500 V
67	8	500.0MV	100.0MV	1.500 V
67	10	500.0MV	100.0MV	1.500 V
67	12	490.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.700 V	
218	4	4.280 V	3.700 V	
224	6	4.280 V	3.700 V	
230	8	4.260 V	3.700 V	
236	10	4.270 V	3.700 V	
242	12	4.280 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-4.000MV		100.0MV

275	6	-6.000MV	100.0MV
281	8	-6.000MV	100.0MV
287	10	-6.000MV	100.0MV
293	12	-6.000MV	100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	112.0MV		400.0MV
322	4	90.00MV		400.0MV
328	6	92.00MV		400.0MV
334	8	110.0MV		400.0MV
340	10	102.0MV		400.0MV
346	12	88.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	0 V		100.0MV
275	6	-2.000MV		100.0MV
281	8	0 V		100.0MV
287	10	0 V		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-3.000NA	-1.000UA	1.000UA
382	1	1.000NA	-1.000UA	1.000UA
387	3	-4.000NA	-1.000UA	1.000UA
390	3	1.000NA	-1.000UA	1.000UA
395	5	-4.000NA	-1.000UA	1.000UA
398	5	1.000NA	-1.000UA	1.000UA
403	9	-4.000NA	-1.000UA	1.000UA
406	9	1.000NA	-1.000UA	1.000UA
411	11	-4.000NA	-1.000UA	1.000UA

414	11	1.000NA	-1.000UA	1.000UA
419	13	-4.000NA	-1.000UA	1.000UA
422	13	1.000NA	-1.000UA	1.000UA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	100.0NA		40.00UA
458	14	200.0NA		40.00UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	740.0UA		2.400MA
500	14	730.0UA		2.400MA
500	14	730.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	710.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 08/20/11 09:52
TEST PROGRAM HCT04 S/N 8
DDS-101-13-A PN 54HCT04 TEST SEQ12 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-610.0MV	-1.500 V	-100.0MV
57	3	-600.0MV	-1.500 V	-100.0MV
57	5	-600.0MV	-1.500 V	-100.0MV
57	9	-600.0MV	-1.500 V	-100.0MV
57	11	-600.0MV	-1.500 V	-100.0MV
57	13	-590.0MV	-1.500 V	-100.0MV
57	14	-450.0MV	-1.500 V	-100.0MV
67	2	500.0MV	100.0MV	1.500 V
67	4	500.0MV	100.0MV	1.500 V
67	6	500.0MV	100.0MV	1.500 V
67	8	500.0MV	100.0MV	1.500 V
67	10	490.0MV	100.0MV	1.500 V
67	12	490.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.700 V	
218	4	4.270 V	3.700 V	
224	6	4.270 V	3.700 V	
230	8	4.240 V	3.700 V	
236	10	4.260 V	3.700 V	
242	12	4.280 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV	100.0MV
281	8	-8.000MV	100.0MV
287	10	-6.000MV	100.0MV
293	12	-6.000MV	100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	114.0MV		400.0MV
322	4	94.00MV		400.0MV
328	6	92.00MV		400.0MV
334	8	118.0MV		400.0MV
340	10	102.0MV		400.0MV
346	12	92.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	0 V		100.0MV
275	6	0 V		100.0MV
281	8	-2.000MV		100.0MV
287	10	0 V		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-1.000UA	1.000UA
382	1	1.000NA	-1.000UA	1.000UA
387	3	-4.000NA	-1.000UA	1.000UA
390	3	1.000NA	-1.000UA	1.000UA
395	5	-4.000NA	-1.000UA	1.000UA
398	5	1.000NA	-1.000UA	1.000UA
403	9	-4.000NA	-1.000UA	1.000UA
406	9	1.000NA	-1.000UA	1.000UA
411	11	-4.000NA	-1.000UA	1.000UA

414	11	1.000NA	-1.000UA	1.000UA
419	13	-4.000NA	-1.000UA	1.000UA
422	13	1.000NA	-1.000UA	1.000UA

```

-----
      ICC TEST
      VCC= 6
      ICC LIMIT MAX. 1.0UA @25C/-55C
      ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	100.0NA		40.00UA
458	14	100.0NA		40.00UA

```

-----
      ICC - DELTA TEST
      VCC= 5.5
      ICC LIMIT MAX. 2.4MA @25C/+125C
      ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	710.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	660.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	700.0UA		2.400MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS     EOT

```

STAT1 08/20/11 09:52
 TEST PROGRAM HCT04 S/N 9
 DDS-101-13-A PN 54HCT04 TEST SEQ12 +125C

 CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-590.0MV	-1.500 V	-100.0MV
57	3	-590.0MV	-1.500 V	-100.0MV
57	5	-580.0MV	-1.500 V	-100.0MV
57	9	-580.0MV	-1.500 V	-100.0MV
57	11	-580.0MV	-1.500 V	-100.0MV
57	13	-580.0MV	-1.500 V	-100.0MV
57	14	-430.0MV	-1.500 V	-100.0MV
67	2	490.0MV	100.0MV	1.500 V
67	4	480.0MV	100.0MV	1.500 V
67	6	480.0MV	100.0MV	1.500 V
67	8	480.0MV	100.0MV	1.500 V
67	10	470.0MV	100.0MV	1.500 V
67	12	470.0MV	100.0MV	1.500 V

 FUNCTIONAL TEST
 VCC= 4.500
 VIH= 2 VIL= 800.0E-03

 VOH1 TEST
 VCC= 4.500
 VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

 VOH2 TEST
 VCC= 4.500
 VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.700 V	
218	4	4.270 V	3.700 V	
224	6	4.270 V	3.700 V	
230	8	4.240 V	3.700 V	
236	10	4.260 V	3.700 V	
242	12	4.270 V	3.700 V	

 VOL1 TEST
 VCC= 4.500
 VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	118.0MV		400.0MV
322	4	98.00MV		400.0MV
328	6	96.00MV		400.0MV
334	8	126.0MV		400.0MV
340	10	108.0MV		400.0MV
346	12	94.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	-2.000MV		100.0MV
275	6	0 V		100.0MV
281	8	-2.000MV		100.0MV
287	10	0 V		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-1.000UA	1.000UA
382	1	1.000NA	-1.000UA	1.000UA
387	3	-4.000NA	-1.000UA	1.000UA
390	3	1.000NA	-1.000UA	1.000UA
395	5	-4.000NA	-1.000UA	1.000UA
398	5	1.000NA	-1.000UA	1.000UA
403	9	-4.000NA	-1.000UA	1.000UA
406	9	1.000NA	-1.000UA	1.000UA
411	11	-4.000NA	-1.000UA	1.000UA

414	11	1.000NA	-1.000UA	1.000UA
419	13	-4.000NA	-1.000UA	1.000UA
422	13	1.000NA	-1.000UA	1.000UA

 ICC TEST
 VCC= 6
 ICC LIMIT MAX. 1.0UA @25C/-55C
 ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	100.0NA		40.00UA
458	14	200.0NA		40.00UA

 ICC - DELTA TEST
 VCC= 5.5
 ICC LIMIT MAX. 2.4MA @25C/+125C
 ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	680.0UA		2.400MA
500	14	660.0UA		2.400MA
500	14	650.0UA		2.400MA
500	14	620.0UA		2.400MA
500	14	620.0UA		2.400MA
500	14	650.0UA		2.400MA

EIR 1.....10 FCT DCT
 0000000000 PASS PASS EOT

STAT1 08/20/11 09:52
TEST PROGRAM HCT04 S/N 10

DDS-101-13-A PN 54HCT04 TEST SEQ12 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-610.0MV	-1.500 V	-100.0MV
57	3	-610.0MV	-1.500 V	-100.0MV
57	5	-600.0MV	-1.500 V	-100.0MV
57	9	-600.0MV	-1.500 V	-100.0MV
57	11	-600.0MV	-1.500 V	-100.0MV
57	13	-600.0MV	-1.500 V	-100.0MV
57	14	-460.0MV	-1.500 V	-100.0MV
67	2	510.0MV	100.0MV	1.500 V
67	4	500.0MV	100.0MV	1.500 V
67	6	500.0MV	100.0MV	1.500 V
67	8	500.0MV	100.0MV	1.500 V
67	10	500.0MV	100.0MV	1.500 V
67	12	500.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.700 V	
218	4	4.270 V	3.700 V	
224	6	4.270 V	3.700 V	
230	8	4.220 V	3.700 V	
236	10	4.260 V	3.700 V	
242	12	4.270 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV	100.0MV
281	8	-6.000MV	100.0MV
287	10	-6.000MV	100.0MV
293	12	-6.000MV	100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	114.0MV		400.0MV
322	4	94.00MV		400.0MV
328	6	94.00MV		400.0MV
334	8	148.0MV		400.0MV
340	10	104.0MV		400.0MV
346	12	92.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	2.000MV		100.0MV
269	4	0 V		100.0MV
275	6	-2.000MV		100.0MV
281	8	0 V		100.0MV
287	10	0 V		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-1.000UA	1.000UA
382	1	1.000NA	-1.000UA	1.000UA
387	3	-4.000NA	-1.000UA	1.000UA
390	3	1.000NA	-1.000UA	1.000UA
395	5	-4.000NA	-1.000UA	1.000UA
398	5	1.000NA	-1.000UA	1.000UA
403	9	-4.000NA	-1.000UA	1.000UA
406	9	1.000NA	-1.000UA	1.000UA
411	11	-4.000NA	-1.000UA	1.000UA

414	11	1.000NA	-1.000UA	1.000UA
419	13	-4.000NA	-1.000UA	1.000UA
422	13	1.000NA	-1.000UA	1.000UA

 ICC TEST
 VCC= 6
 ICC LIMIT MAX. 1.0UA @25C/-55C
 ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	0 A		40.00UA
458	14	100.0NA		40.00UA

 ICC - DELTA TEST
 VCC= 5.5
 ICC LIMIT MAX. 2.4MA @25C/+125C
 ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	690.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	650.0UA		2.400MA
500	14	650.0UA		2.400MA
500	14	680.0UA		2.400MA

EIR 1.....10	FCT	DCT	
0000000000	PASS	PASS	EOT

STAT1 08/20/11 09:52
TEST PROGRAM HCT04 S/N 11
DDS-101-13-A PN 54HCT04 TEST SEQ12 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-600.0MV	-1.500 V	-100.0MV
57	3	-600.0MV	-1.500 V	-100.0MV
57	5	-600.0MV	-1.500 V	-100.0MV
57	9	-590.0MV	-1.500 V	-100.0MV
57	11	-590.0MV	-1.500 V	-100.0MV
57	13	-590.0MV	-1.500 V	-100.0MV
57	14	-440.0MV	-1.500 V	-100.0MV
67	2	500.0MV	100.0MV	1.500 V
67	4	490.0MV	100.0MV	1.500 V
67	6	490.0MV	100.0MV	1.500 V
67	8	490.0MV	100.0MV	1.500 V
67	10	490.0MV	100.0MV	1.500 V
67	12	480.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.700 V	
218	4	4.270 V	3.700 V	
224	6	4.270 V	3.700 V	
230	8	4.250 V	3.700 V	
236	10	4.260 V	3.700 V	
242	12	4.270 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	114.0MV		400.0MV
322	4	92.00MV		400.0MV
328	6	92.00MV		400.0MV
334	8	112.0MV		400.0MV
340	10	102.0MV		400.0MV
346	12	90.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	2.000MV		100.0MV
269	4	0 V		100.0MV
275	6	0 V		100.0MV
281	8	0 V		100.0MV
287	10	0 V		100.0MV
293	12	2.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-1.000UA	1.000UA
382	1	1.000NA	-1.000UA	1.000UA
387	3	-4.000NA	-1.000UA	1.000UA
390	3	1.000NA	-1.000UA	1.000UA
395	5	-4.000NA	-1.000UA	1.000UA
398	5	1.000NA	-1.000UA	1.000UA
403	9	-4.000NA	-1.000UA	1.000UA
406	9	1.000NA	-1.000UA	1.000UA
411	11	-4.000NA	-1.000UA	1.000UA

414	11	1.000NA	-1.000UA	1.000UA
419	13	-4.000NA	-1.000UA	1.000UA
422	13	1.000NA	-1.000UA	1.000UA

 ICC TEST
 VCC= 6
 ICC LIMIT MAX. 1.0UA @25C/-55C
 ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	100.0NA		40.00UA
458	14	200.0NA		40.00UA

 ICC - DELTA TEST
 VCC= 5.5
 ICC LIMIT MAX. 2.4MA @25C/+125C
 ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	750.0UA		2.400MA
500	14	730.0UA		2.400MA
500	14	720.0UA		2.400MA
500	14	710.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	720.0UA		2.400MA

EIR 1.....10	FCT	DCT	
0000000000	PASS	PASS	EOT

STAT1 08/20/11 09:52
 TEST PROGRAM HCT04 S/N 12
 DDS-101-13-A PN 54HCT04 TEST SEQ12 +125C

 CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-610.0MV	-1.500 V	-100.0MV
57	3	-600.0MV	-1.500 V	-100.0MV
57	5	-600.0MV	-1.500 V	-100.0MV
57	9	-600.0MV	-1.500 V	-100.0MV
57	11	-600.0MV	-1.500 V	-100.0MV
57	13	-590.0MV	-1.500 V	-100.0MV
57	14	-450.0MV	-1.500 V	-100.0MV
67	2	500.0MV	100.0MV	1.500 V
67	4	500.0MV	100.0MV	1.500 V
67	6	490.0MV	100.0MV	1.500 V
67	8	490.0MV	100.0MV	1.500 V
67	10	500.0MV	100.0MV	1.500 V
67	12	490.0MV	100.0MV	1.500 V

 FUNCTIONAL TEST
 VCC= 4.500
 VIH= 2 VIL= 800.0E-03

 VOH1 TEST
 VCC= 4.500
 VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

 VOH2 TEST
 VCC= 4.500
 VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.700 V	
218	4	4.270 V	3.700 V	
224	6	4.270 V	3.700 V	
230	8	4.250 V	3.700 V	
236	10	4.260 V	3.700 V	
242	12	4.270 V	3.700 V	

 VOL1 TEST
 VCC= 4.500
 VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV	100.0MV
281	8	-6.000MV	100.0MV
287	10	-4.000MV	100.0MV
293	12	-6.000MV	100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	114.0MV		400.0MV
322	4	94.00MV		400.0MV
328	6	92.00MV		400.0MV
334	8	112.0MV		400.0MV
340	10	104.0MV		400.0MV
346	12	92.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	2.000MV		100.0MV
269	4	0 V		100.0MV
275	6	-2.000MV		100.0MV
281	8	0 V		100.0MV
287	10	0 V		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-1.000UA	1.000UA
382	1	1.000NA	-1.000UA	1.000UA
387	3	-4.000NA	-1.000UA	1.000UA
390	3	1.000NA	-1.000UA	1.000UA
395	5	-4.000NA	-1.000UA	1.000UA
398	5	1.000NA	-1.000UA	1.000UA
403	9	-4.000NA	-1.000UA	1.000UA
406	9	1.000NA	-1.000UA	1.000UA
411	11	-4.000NA	-1.000UA	1.000UA

414	11	1.000NA	-1.000UA	1.000UA
419	13	-4.000NA	-1.000UA	1.000UA
422	13	1.000NA	-1.000UA	1.000UA

```

-----
      ICC TEST
      VCC= 6
      ICC LIMIT MAX. 1.0UA @25C/-55C
      ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	0 A		40.00UA
458	14	100.0NA		40.00UA

```

-----
      ICC - DELTA TEST
      VCC= 5.5
      ICC LIMIT MAX. 2.4MA @25C/+125C
      ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	700.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	650.0UA		2.400MA
500	14	650.0UA		2.400MA
500	14	680.0UA		2.400MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS     EOT

```



MIL-PRF-38534 CLASS K DATAPACK

Post Burn-In Test Results at -55°C



STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 1

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-720.0MV	-1.500 V	-100.0MV
57	3	-710.0MV	-1.500 V	-100.0MV
57	5	-710.0MV	-1.500 V	-100.0MV
57	9	-720.0MV	-1.500 V	-100.0MV
57	11	-720.0MV	-1.500 V	-100.0MV
57	13	-720.0MV	-1.500 V	-100.0MV
57	14	-600.0MV	-1.500 V	-100.0MV
67	2	630.0MV	100.0MV	1.500 V
67	4	630.0MV	100.0MV	1.500 V
67	6	630.0MV	100.0MV	1.500 V
67	8	630.0MV	100.0MV	1.500 V
67	10	630.0MV	100.0MV	1.500 V
67	12	630.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.330 V	3.980 V	
218	4	4.330 V	3.980 V	
224	6	4.330 V	3.980 V	
230	8	4.330 V	3.980 V	
236	10	4.330 V	3.980 V	
242	12	4.340 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV
275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV

287	10	-6.000MV	100.0MV
293	12	-8.000MV	100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	68.00MV		260.0MV
322	4	56.00MV		260.0MV
328	6	54.00MV		260.0MV
334	8	54.00MV		260.0MV
340	10	56.00MV		260.0MV
346	12	56.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-89.00NA	-100.0NA	100.0NA
390	3	-14.00NA	-100.0NA	100.0NA
395	5	-14.00NA	-100.0NA	100.0NA
398	5	1.000NA	-100.0NA	100.0NA
403	9	-11.00NA	-100.0NA	100.0NA
406	9	3.000NA	-100.0NA	100.0NA
411	11	-8.000NA	-100.0NA	100.0NA
414	11	2.000NA	-100.0NA	100.0NA
419	13	-24.00NA	-100.0NA	100.0NA

422 13 1.000NA -100.0NA 100.0NA

ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	40.00NA		1.000UA
458	14	3.000NA		1.000UA

ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	720.0UA		2.900MA
500	14	690.0UA		2.900MA
500	14	680.0UA		2.900MA
500	14	660.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	700.0UA		2.900MA

EIR 1.....10 FCT DCT
0000000000 PASS PASS EOT

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 2

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-720.0MV	-1.500 V	-100.0MV
57	3	-720.0MV	-1.500 V	-100.0MV
57	5	-720.0MV	-1.500 V	-100.0MV
57	9	-720.0MV	-1.500 V	-100.0MV
57	11	-720.0MV	-1.500 V	-100.0MV
57	13	-730.0MV	-1.500 V	-100.0MV
57	14	-610.0MV	-1.500 V	-100.0MV
67	2	640.0MV	100.0MV	1.500 V
67	4	640.0MV	100.0MV	1.500 V
67	6	650.0MV	100.0MV	1.500 V
67	8	650.0MV	100.0MV	1.500 V
67	10	650.0MV	100.0MV	1.500 V
67	12	650.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.330 V	3.980 V	
218	4	4.330 V	3.980 V	
224	6	4.340 V	3.980 V	
230	8	4.340 V	3.980 V	
236	10	4.340 V	3.980 V	
242	12	4.340 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-8.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-8.000MV		100.0MV
281	8	-8.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	62.00MV		260.0MV
322	4	54.00MV		260.0MV
328	6	52.00MV		260.0MV
334	8	50.00MV		260.0MV
340	10	52.00MV		260.0MV
346	12	52.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-89.00NA	-100.0NA	100.0NA
390	3	-14.00NA	-100.0NA	100.0NA
395	5	-14.00NA	-100.0NA	100.0NA
398	5	1.000NA	-100.0NA	100.0NA
403	9	-10.00NA	-100.0NA	100.0NA
406	9	2.000NA	-100.0NA	100.0NA
411	11	-8.000NA	-100.0NA	100.0NA

414	11	1.000NA	-100.0NA	100.0NA
419	13	-96.00NA	-100.0NA	100.0NA
422	13	1.000NA	-100.0NA	100.0NA

```

-----
      ICC TEST
      VCC= 6
      ICC LIMIT MAX. 1.0UA @25C/-55C
      ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	125.0NA		1.000UA
458	14	10.00NA		1.000UA

```

-----
      ICC - DELTA TEST
      VCC= 5.5
      ICC LIMIT MAX. 2.4MA @25C/+125C
      ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	740.0UA		2.900MA
500	14	690.0UA		2.900MA
500	14	680.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	680.0UA		2.900MA
500	14	730.0UA		2.900MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS     EOT

```

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 3

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-670.0MV	-1.500 V	-100.0MV
57	3	-680.0MV	-1.500 V	-100.0MV
57	5	-680.0MV	-1.500 V	-100.0MV
57	9	-680.0MV	-1.500 V	-100.0MV
57	11	-680.0MV	-1.500 V	-100.0MV
57	13	-680.0MV	-1.500 V	-100.0MV
57	14	-560.0MV	-1.500 V	-100.0MV
67	2	600.0MV	100.0MV	1.500 V
67	4	600.0MV	100.0MV	1.500 V
67	6	600.0MV	100.0MV	1.500 V
67	8	610.0MV	100.0MV	1.500 V
67	10	610.0MV	100.0MV	1.500 V
67	12	610.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.310 V	3.980 V	
218	4	4.320 V	3.980 V	
224	6	4.330 V	3.980 V	
230	8	4.330 V	3.980 V	
236	10	4.320 V	3.980 V	
242	12	4.320 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-8.000MV		100.0MV
287	10	-8.000MV		100.0MV
293	12	-8.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	78.00MV		260.0MV
322	4	58.00MV		260.0MV
328	6	56.00MV		260.0MV
334	8	54.00MV		260.0MV
340	10	58.00MV		260.0MV
346	12	58.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-6.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-86.00NA	-100.0NA	100.0NA
390	3	-12.00NA	-100.0NA	100.0NA
395	5	-14.00NA	-100.0NA	100.0NA
398	5	3.000NA	-100.0NA	100.0NA
403	9	-11.00NA	-100.0NA	100.0NA
406	9	3.000NA	-100.0NA	100.0NA
411	11	-8.000NA	-100.0NA	100.0NA

414	11	2.000NA	-100.0NA	100.0NA
419	13	-50.00NA	-100.0NA	100.0NA
422	13	3.000NA	-100.0NA	100.0NA

```

-----
      ICC TEST
      VCC= 6
      ICC LIMIT MAX. 1.0UA @25C/-55C
      ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	70.00NA		1.000UA
458	14	4.000NA		1.000UA

```

-----
      ICC - DELTA TEST
      VCC= 5.5
      ICC LIMIT MAX. 2.4MA @25C/+125C
      ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	670.0UA		2.900MA
500	14	660.0UA		2.900MA
500	14	660.0UA		2.900MA
500	14	620.0UA		2.900MA
500	14	610.0UA		2.900MA
500	14	640.0UA		2.900MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS      PASS      EOT

```


STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 4

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-730.0MV	-1.500 V	-100.0MV
57	3	-730.0MV	-1.500 V	-100.0MV
57	5	-730.0MV	-1.500 V	-100.0MV
57	9	-730.0MV	-1.500 V	-100.0MV
57	11	-730.0MV	-1.500 V	-100.0MV
57	13	-730.0MV	-1.500 V	-100.0MV
57	14	-610.0MV	-1.500 V	-100.0MV
67	2	650.0MV	100.0MV	1.500 V
67	4	650.0MV	100.0MV	1.500 V
67	6	650.0MV	100.0MV	1.500 V
67	8	650.0MV	100.0MV	1.500 V
67	10	650.0MV	100.0MV	1.500 V
67	12	650.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.320 V	3.980 V	
218	4	4.330 V	3.980 V	
224	6	4.340 V	3.980 V	
230	8	4.340 V	3.980 V	
236	10	4.340 V	3.980 V	
242	12	4.340 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-8.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-8.000MV		100.0MV
287	10	-8.000MV		100.0MV
293	12	-8.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	72.00MV		260.0MV
322	4	52.00MV		260.0MV
328	6	52.00MV		260.0MV
334	8	52.00MV		260.0MV
340	10	54.00MV		260.0MV
346	12	50.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-6.000MV		100.0MV
275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-87.00NA	-100.0NA	100.0NA
390	3	-13.00NA	-100.0NA	100.0NA
395	5	-14.00NA	-100.0NA	100.0NA
398	5	1.000NA	-100.0NA	100.0NA
403	9	-11.00NA	-100.0NA	100.0NA
406	9	3.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA

414	11	1.000NA	-100.0NA	100.0NA
419	13	-91.00NA	-100.0NA	100.0NA
422	13	10.00NA	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	120.0NA		1.000UA
458	14	8.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	700.0UA		2.900MA
500	14	680.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	660.0UA		2.900MA
500	14	660.0UA		2.900MA
500	14	690.0UA		2.900MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 5

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-650.0MV	-1.500 V	-100.0MV
57	3	-650.0MV	-1.500 V	-100.0MV
57	5	-650.0MV	-1.500 V	-100.0MV
57	9	-650.0MV	-1.500 V	-100.0MV
57	11	-650.0MV	-1.500 V	-100.0MV
57	13	-650.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.290 V	3.980 V	
218	4	4.310 V	3.980 V	
224	6	4.310 V	3.980 V	
230	8	4.310 V	3.980 V	
236	10	4.310 V	3.980 V	
242	12	4.310 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-8.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	84.00MV		260.0MV
322	4	68.00MV		260.0MV
328	6	66.00MV		260.0MV
334	8	66.00MV		260.0MV
340	10	70.00MV		260.0MV
346	12	66.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-7.000NA	-100.0NA	100.0NA
390	3	5.000NA	-100.0NA	100.0NA
395	5	-7.000NA	-100.0NA	100.0NA
398	5	8.000NA	-100.0NA	100.0NA
403	9	-8.000NA	-100.0NA	100.0NA
406	9	7.000NA	-100.0NA	100.0NA
411	11	-6.000NA	-100.0NA	100.0NA

414	11	4.000NA	-100.0NA	100.0NA
419	13	-34.00NA	-100.0NA	100.0NA
422	13	3.000NA	-100.0NA	100.0NA

 ICC TEST
 VCC= 6
 ICC LIMIT MAX. 1.0UA @25C/-55C
 ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	55.00NA		1.000UA
458	14	5.000NA		1.000UA

 ICC - DELTA TEST
 VCC= 5.5
 ICC LIMIT MAX. 2.4MA @25C/+125C
 ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	700.0UA		2.900MA
500	14	690.0UA		2.900MA
500	14	660.0UA		2.900MA
500	14	620.0UA		2.900MA
500	14	630.0UA		2.900MA
500	14	660.0UA		2.900MA

EIR 1.....10	FCT	DCT	
000000000	PASS	PASS	EOT

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 6

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-740.0MV	-1.500 V	-100.0MV
57	3	-740.0MV	-1.500 V	-100.0MV
57	5	-740.0MV	-1.500 V	-100.0MV
57	9	-740.0MV	-1.500 V	-100.0MV
57	11	-740.0MV	-1.500 V	-100.0MV
57	13	-740.0MV	-1.500 V	-100.0MV
57	14	-620.0MV	-1.500 V	-100.0MV
67	2	660.0MV	100.0MV	1.500 V
67	4	650.0MV	100.0MV	1.500 V
67	6	660.0MV	100.0MV	1.500 V
67	8	650.0MV	100.0MV	1.500 V
67	10	660.0MV	100.0MV	1.500 V
67	12	660.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.320 V	3.980 V	
218	4	4.330 V	3.980 V	
224	6	4.340 V	3.980 V	
230	8	4.330 V	3.980 V	
236	10	4.330 V	3.980 V	
242	12	4.340 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-8.000MV		100.0MV
269	4	-8.000MV		100.0MV

275	6	-8.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-8.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	70.00MV		260.0MV
322	4	54.00MV		260.0MV
328	6	52.00MV		260.0MV
334	8	50.00MV		260.0MV
340	10	54.00MV		260.0MV
346	12	54.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	2.000NA	-100.0NA	100.0NA
387	3	-87.00NA	-100.0NA	100.0NA
390	3	-13.00NA	-100.0NA	100.0NA
395	5	-15.00NA	-100.0NA	100.0NA
398	5	1.000NA	-100.0NA	100.0NA
403	9	-10.00NA	-100.0NA	100.0NA
406	9	3.000NA	-100.0NA	100.0NA
411	11	-8.000NA	-100.0NA	100.0NA

414	11	1.000NA	-100.0NA	100.0NA
419	13	-49.00NA	-100.0NA	100.0NA
422	13	2.000NA	-100.0NA	100.0NA

 ICC TEST
 VCC= 6
 ICC LIMIT MAX. 1.0UA @25C/-55C
 ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	91.00NA		1.000UA
458	14	5.000NA		1.000UA

 ICC - DELTA TEST
 VCC= 5.5
 ICC LIMIT MAX. 2.4MA @25C/+125C
 ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	700.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	660.0UA		2.900MA
500	14	650.0UA		2.900MA
500	14	680.0UA		2.900MA

EIR 1.....10 FCT DCT
 0000000000 PASS PASS EOT

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 7

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-700.0MV	-1.500 V	-100.0MV
57	3	-700.0MV	-1.500 V	-100.0MV
57	5	-700.0MV	-1.500 V	-100.0MV
57	9	-700.0MV	-1.500 V	-100.0MV
57	11	-700.0MV	-1.500 V	-100.0MV
57	13	-700.0MV	-1.500 V	-100.0MV
57	14	-580.0MV	-1.500 V	-100.0MV
67	2	620.0MV	100.0MV	1.500 V
67	4	620.0MV	100.0MV	1.500 V
67	6	620.0MV	100.0MV	1.500 V
67	8	630.0MV	100.0MV	1.500 V
67	10	630.0MV	100.0MV	1.500 V
67	12	630.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.320 V	3.980 V	
218	4	4.330 V	3.980 V	
224	6	4.330 V	3.980 V	
230	8	4.330 V	3.980 V	
236	10	4.330 V	3.980 V	
242	12	4.330 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-8.000MV		100.0MV
269	4	-8.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	70.00MV		260.0MV
322	4	54.00MV		260.0MV
328	6	52.00MV		260.0MV
334	8	50.00MV		260.0MV
340	10	54.00MV		260.0MV
346	12	54.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-87.00NA	-100.0NA	100.0NA
390	3	-12.00NA	-100.0NA	100.0NA
395	5	-16.00NA	-100.0NA	100.0NA
398	5	4.000NA	-100.0NA	100.0NA
403	9	-11.00NA	-100.0NA	100.0NA
406	9	3.000NA	-100.0NA	100.0NA
411	11	-8.000NA	-100.0NA	100.0NA

414	11	2.000NA	-100.0NA	100.0NA
419	13	-27.00NA	-100.0NA	100.0NA
422	13	1.000NA	-100.0NA	100.0NA

 ICC TEST
 VCC= 6
 ICC LIMIT MAX. 1.0UA @25C/-55C
 ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	47.00NA		1.000UA
458	14	2.000NA		1.000UA

 ICC - DELTA TEST
 VCC= 5.5
 ICC LIMIT MAX. 2.4MA @25C/+125C
 ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	720.0UA		2.900MA
500	14	710.0UA		2.900MA
500	14	710.0UA		2.900MA
500	14	640.0UA		2.900MA
500	14	660.0UA		2.900MA
500	14	690.0UA		2.900MA

EIR 1.....10 FCT DCT
 0000000000 PASS PASS EOT

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 8

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-670.0MV	-1.500 V	-100.0MV
57	3	-680.0MV	-1.500 V	-100.0MV
57	5	-670.0MV	-1.500 V	-100.0MV
57	9	-670.0MV	-1.500 V	-100.0MV
57	11	-680.0MV	-1.500 V	-100.0MV
57	13	-680.0MV	-1.500 V	-100.0MV
57	14	-550.0MV	-1.500 V	-100.0MV
67	2	590.0MV	100.0MV	1.500 V
67	4	600.0MV	100.0MV	1.500 V
67	6	600.0MV	100.0MV	1.500 V
67	8	600.0MV	100.0MV	1.500 V
67	10	600.0MV	100.0MV	1.500 V
67	12	600.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.300 V	3.980 V	
218	4	4.320 V	3.980 V	
224	6	4.330 V	3.980 V	
230	8	4.320 V	3.980 V	
236	10	4.320 V	3.980 V	
242	12	4.320 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-8.000MV		100.0MV

275	6	-8.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	76.00MV		260.0MV
322	4	58.00MV		260.0MV
328	6	58.00MV		260.0MV
334	8	58.00MV		260.0MV
340	10	60.00MV		260.0MV
346	12	60.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-6.000MV		100.0MV
275	6	-6.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-2.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	2.000NA	-100.0NA	100.0NA
387	3	-87.00NA	-100.0NA	100.0NA
390	3	-12.00NA	-100.0NA	100.0NA
395	5	-16.00NA	-100.0NA	100.0NA
398	5	4.000NA	-100.0NA	100.0NA
403	9	-11.00NA	-100.0NA	100.0NA
406	9	4.000NA	-100.0NA	100.0NA
411	11	-8.000NA	-100.0NA	100.0NA

414	11	1.000NA	-100.0NA	100.0NA
419	13	-32.00NA	-100.0NA	100.0NA
422	13	1.000NA	-100.0NA	100.0NA

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-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
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```

INST #	PIN	MEASURED	LT	GT
451	14	52.00NA		1.000UA
458	14	3.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	690.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	620.0UA		2.900MA
500	14	630.0UA		2.900MA
500	14	660.0UA		2.900MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

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STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 9

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-700.0MV	-1.500 V	-100.0MV
57	3	-700.0MV	-1.500 V	-100.0MV
57	5	-700.0MV	-1.500 V	-100.0MV
57	9	-710.0MV	-1.500 V	-100.0MV
57	11	-710.0MV	-1.500 V	-100.0MV
57	13	-710.0MV	-1.500 V	-100.0MV
57	14	-590.0MV	-1.500 V	-100.0MV
67	2	630.0MV	100.0MV	1.500 V
67	4	630.0MV	100.0MV	1.500 V
67	6	630.0MV	100.0MV	1.500 V
67	8	630.0MV	100.0MV	1.500 V
67	10	630.0MV	100.0MV	1.500 V
67	12	630.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.320 V	3.980 V	
218	4	4.330 V	3.980 V	
224	6	4.330 V	3.980 V	
230	8	4.330 V	3.980 V	
236	10	4.330 V	3.980 V	
242	12	4.330 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-8.000MV		100.0MV
269	4	-8.000MV		100.0MV

275	6	-8.000MV		100.0MV
281	8	-8.000MV		100.0MV
287	10	-8.000MV		100.0MV
293	12	-8.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	74.00MV		260.0MV
322	4	54.00MV		260.0MV
328	6	54.00MV		260.0MV
334	8	54.00MV		260.0MV
340	10	56.00MV		260.0MV
346	12	56.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-2.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-6.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	2.000NA	-100.0NA	100.0NA
387	3	-85.00NA	-100.0NA	100.0NA
390	3	-13.00NA	-100.0NA	100.0NA
395	5	-14.00NA	-100.0NA	100.0NA
398	5	1.000NA	-100.0NA	100.0NA
403	9	-10.00NA	-100.0NA	100.0NA
406	9	2.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA

414	11	1.000NA	-100.0NA	100.0NA
419	13	-16.00NA	-100.0NA	100.0NA
422	13	1.000NA	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	34.00NA		1.000UA
458	14	2.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	650.0UA		2.900MA
500	14	630.0UA		2.900MA
500	14	620.0UA		2.900MA
500	14	590.0UA		2.900MA
500	14	590.0UA		2.900MA
500	14	620.0UA		2.900MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 10

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-710.0MV	-1.500 V	-100.0MV
57	3	-710.0MV	-1.500 V	-100.0MV
57	5	-710.0MV	-1.500 V	-100.0MV
57	9	-710.0MV	-1.500 V	-100.0MV
57	11	-710.0MV	-1.500 V	-100.0MV
57	13	-710.0MV	-1.500 V	-100.0MV
57	14	-590.0MV	-1.500 V	-100.0MV
67	2	630.0MV	100.0MV	1.500 V
67	4	630.0MV	100.0MV	1.500 V
67	6	640.0MV	100.0MV	1.500 V
67	8	640.0MV	100.0MV	1.500 V
67	10	640.0MV	100.0MV	1.500 V
67	12	640.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.320 V	3.980 V	
218	4	4.330 V	3.980 V	
224	6	4.330 V	3.980 V	
230	8	4.330 V	3.980 V	
236	10	4.330 V	3.980 V	
242	12	4.330 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-8.000MV		100.0MV

275	6	-6.000MV	100.0MV
281	8	-6.000MV	100.0MV
287	10	-6.000MV	100.0MV
293	12	-6.000MV	100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	70.00MV		260.0MV
322	4	52.00MV		260.0MV
328	6	52.00MV		260.0MV
334	8	52.00MV		260.0MV
340	10	54.00MV		260.0MV
346	12	54.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-6.000MV		100.0MV
275	6	-6.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-87.00NA	-100.0NA	100.0NA
390	3	-13.00NA	-100.0NA	100.0NA
395	5	-16.00NA	-100.0NA	100.0NA
398	5	3.000NA	-100.0NA	100.0NA
403	9	-11.00NA	-100.0NA	100.0NA
406	9	3.000NA	-100.0NA	100.0NA
411	11	-8.000NA	-100.0NA	100.0NA

414	11	2.000NA	-100.0NA	100.0NA
419	13	-22.00NA	-100.0NA	100.0NA
422	13	1.000NA	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	38.00NA		1.000UA
458	14	2.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	670.0UA		2.900MA
500	14	660.0UA		2.900MA
500	14	660.0UA		2.900MA
500	14	630.0UA		2.900MA
500	14	620.0UA		2.900MA
500	14	660.0UA		2.900MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 11

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-710.0MV	-1.500 V	-100.0MV
57	3	-710.0MV	-1.500 V	-100.0MV
57	5	-720.0MV	-1.500 V	-100.0MV
57	9	-720.0MV	-1.500 V	-100.0MV
57	11	-720.0MV	-1.500 V	-100.0MV
57	13	-720.0MV	-1.500 V	-100.0MV
57	14	-600.0MV	-1.500 V	-100.0MV
67	2	640.0MV	100.0MV	1.500 V
67	4	640.0MV	100.0MV	1.500 V
67	6	640.0MV	100.0MV	1.500 V
67	8	640.0MV	100.0MV	1.500 V
67	10	640.0MV	100.0MV	1.500 V
67	12	640.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.320 V	3.980 V	
218	4	4.330 V	3.980 V	
224	6	4.340 V	3.980 V	
230	8	4.340 V	3.980 V	
236	10	4.330 V	3.980 V	
242	12	4.340 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-8.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	68.00MV		260.0MV
322	4	50.00MV		260.0MV
328	6	48.00MV		260.0MV
334	8	48.00MV		260.0MV
340	10	50.00MV		260.0MV
346	12	52.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-6.000MV		100.0MV
275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-87.00NA	-100.0NA	100.0NA
390	3	-12.00NA	-100.0NA	100.0NA
395	5	-16.00NA	-100.0NA	100.0NA
398	5	4.000NA	-100.0NA	100.0NA
403	9	-11.00NA	-100.0NA	100.0NA
406	9	4.000NA	-100.0NA	100.0NA
411	11	-8.000NA	-100.0NA	100.0NA

414	11	2.000NA	-100.0NA	100.0NA
419	13	-46.00NA	-100.0NA	100.0NA
422	13	3.000NA	-100.0NA	100.0NA

 ICC TEST
 VCC= 6
 ICC LIMIT MAX. 1.0UA @25C/-55C
 ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	68.00NA		1.000UA
458	14	4.000NA		1.000UA

 ICC - DELTA TEST
 VCC= 5.5
 ICC LIMIT MAX. 2.4MA @25C/+125C
 ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	730.0UA		2.900MA
500	14	700.0UA		2.900MA
500	14	690.0UA		2.900MA
500	14	690.0UA		2.900MA
500	14	660.0UA		2.900MA
500	14	700.0UA		2.900MA

EIR 1.....10	FCT	DCT	
0000000000	PASS	PASS	EOT

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 12

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 -55C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-710.0MV	-1.500 V	-100.0MV
57	3	-720.0MV	-1.500 V	-100.0MV
57	5	-720.0MV	-1.500 V	-100.0MV
57	9	-720.0MV	-1.500 V	-100.0MV
57	11	-720.0MV	-1.500 V	-100.0MV
57	13	-720.0MV	-1.500 V	-100.0MV
57	14	-600.0MV	-1.500 V	-100.0MV
67	2	640.0MV	100.0MV	1.500 V
67	4	640.0MV	100.0MV	1.500 V
67	6	640.0MV	100.0MV	1.500 V
67	8	640.0MV	100.0MV	1.500 V
67	10	640.0MV	100.0MV	1.500 V
67	12	640.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.320 V	3.980 V	
218	4	4.330 V	3.980 V	
224	6	4.330 V	3.980 V	
230	8	4.330 V	3.980 V	
236	10	4.330 V	3.980 V	
242	12	4.330 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-8.000MV		100.0MV

275	6	-8.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	72.00MV		260.0MV
322	4	54.00MV		260.0MV
328	6	54.00MV		260.0MV
334	8	52.00MV		260.0MV
340	10	56.00MV		260.0MV
346	12	56.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-6.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-86.00NA	-100.0NA	100.0NA
390	3	-12.00NA	-100.0NA	100.0NA
395	5	-16.00NA	-100.0NA	100.0NA
398	5	4.000NA	-100.0NA	100.0NA
403	9	-11.00NA	-100.0NA	100.0NA
406	9	4.000NA	-100.0NA	100.0NA
411	11	-8.000NA	-100.0NA	100.0NA

414	11	2.000NA	-100.0NA	100.0NA
419	13	-40.00NA	-100.0NA	100.0NA
422	13	2.000NA	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	66.00NA		1.000UA
458	14	4.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	680.0UA		2.900MA
500	14	660.0UA		2.900MA
500	14	670.0UA		2.900MA
500	14	630.0UA		2.900MA
500	14	620.0UA		2.900MA
500	14	650.0UA		2.900MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```



MIL-PRF-38534 CLASS K DATAPACK

Post Burn-In Test Results at 25°C



STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 1

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-650.0MV	-1.500 V	-100.0MV
57	3	-650.0MV	-1.500 V	-100.0MV
57	5	-650.0MV	-1.500 V	-100.0MV
57	9	-650.0MV	-1.500 V	-100.0MV
57	11	-650.0MV	-1.500 V	-100.0MV
57	13	-650.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	560.0MV	100.0MV	1.500 V
67	4	560.0MV	100.0MV	1.500 V
67	6	560.0MV	100.0MV	1.500 V
67	8	560.0MV	100.0MV	1.500 V
67	10	560.0MV	100.0MV	1.500 V
67	12	560.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.310 V	3.980 V	
218	4	4.310 V	3.980 V	
224	6	4.310 V	3.980 V	
230	8	4.310 V	3.980 V	
236	10	4.310 V	3.980 V	
242	12	4.310 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV
275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV

287 10 -6.000MV 100.0MV
293 12 -6.000MV 100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	80.00MV		260.0MV
322	4	68.00MV		260.0MV
328	6	66.00MV		260.0MV
334	8	66.00MV		260.0MV
340	10	70.00MV		260.0MV
346	12	70.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-2.000MV		100.0MV
275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-2.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-7.000NA	-100.0NA	100.0NA
390	3	5.000NA	-100.0NA	100.0NA
395	5	-8.000NA	-100.0NA	100.0NA
398	5	9.000NA	-100.0NA	100.0NA
403	9	-9.000NA	-100.0NA	100.0NA
406	9	9.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA
414	11	6.000NA	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA

422 13 3.000NA -100.0NA 100.0NA

ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	28.00NA		1.000UA
458	14	4.000NA		1.000UA

ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	720.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	710.0UA		2.400MA

EIR 1.....10 FCT DCT
0000000000 PASS PASS EOT

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 2

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-660.0MV	-1.500 V	-100.0MV
57	3	-660.0MV	-1.500 V	-100.0MV
57	5	-660.0MV	-1.500 V	-100.0MV
57	9	-660.0MV	-1.500 V	-100.0MV
57	11	-660.0MV	-1.500 V	-100.0MV
57	13	-660.0MV	-1.500 V	-100.0MV
57	14	-530.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.310 V	3.980 V	
218	4	4.310 V	3.980 V	
224	6	4.320 V	3.980 V	
230	8	4.310 V	3.980 V	
236	10	4.310 V	3.980 V	
242	12	4.320 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-8.000MV		100.0MV
287	10	-8.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	74.00MV		260.0MV
322	4	66.00MV		260.0MV
328	6	66.00MV		260.0MV
334	8	62.00MV		260.0MV
340	10	64.00MV		260.0MV
346	12	66.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-90.00NA	-100.0NA	100.0NA
390	3	-12.00NA	-100.0NA	100.0NA
395	5	-16.00NA	-100.0NA	100.0NA
398	5	4.000NA	-100.0NA	100.0NA
403	9	-13.00NA	-100.0NA	100.0NA
406	9	6.000NA	-100.0NA	100.0NA
411	11	-9.000NA	-100.0NA	100.0NA

414	11	4.000NA	-100.0NA	100.0NA
419	13	-7.000NA	-100.0NA	100.0NA
422	13	2.000NA	-100.0NA	100.0NA

 ICC TEST
 VCC= 6
 ICC LIMIT MAX. 1.0UA @25C/-55C
 ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	26.00NA		1.000UA
458	14	2.000NA		1.000UA

 ICC - DELTA TEST
 VCC= 5.5
 ICC LIMIT MAX. 2.4MA @25C/+125C
 ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	750.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	730.0UA		2.400MA

EIR 1.....10 FCT DCT
 0000000000 PASS PASS EOT

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 3

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-660.0MV	-1.500 V	-100.0MV
57	3	-660.0MV	-1.500 V	-100.0MV
57	5	-660.0MV	-1.500 V	-100.0MV
57	9	-660.0MV	-1.500 V	-100.0MV
57	11	-660.0MV	-1.500 V	-100.0MV
57	13	-660.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.310 V	3.980 V	
218	4	4.310 V	3.980 V	
224	6	4.320 V	3.980 V	
230	8	4.310 V	3.980 V	
236	10	4.310 V	3.980 V	
242	12	4.310 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-8.000MV		100.0MV

275	6	-8.000MV		100.0MV
281	8	-8.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	80.00MV		260.0MV
322	4	68.00MV		260.0MV
328	6	66.00MV		260.0MV
334	8	64.00MV		260.0MV
340	10	68.00MV		260.0MV
346	12	70.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-2.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-7.000NA	-100.0NA	100.0NA
390	3	5.000NA	-100.0NA	100.0NA
395	5	-8.000NA	-100.0NA	100.0NA
398	5	9.000NA	-100.0NA	100.0NA
403	9	-9.000NA	-100.0NA	100.0NA
406	9	8.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA

414	11	6.000NA	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA
422	13	3.000NA	-100.0NA	100.0NA

```

-----
      ICC TEST
      VCC= 6
      ICC LIMIT MAX. 1.0UA @25C/-55C
      ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	27.00NA		1.000UA
458	14	3.000NA		1.000UA

```

-----
      ICC - DELTA TEST
      VCC= 5.5
      ICC LIMIT MAX. 2.4MA @25C/+125C
      ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	680.0UA		2.400MA
500	14	660.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	630.0UA		2.400MA
500	14	620.0UA		2.400MA
500	14	640.0UA		2.400MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS     EOT

```

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 4

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-660.0MV	-1.500 V	-100.0MV
57	3	-660.0MV	-1.500 V	-100.0MV
57	5	-660.0MV	-1.500 V	-100.0MV
57	9	-660.0MV	-1.500 V	-100.0MV
57	11	-660.0MV	-1.500 V	-100.0MV
57	13	-660.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.310 V	3.980 V	
218	4	4.310 V	3.980 V	
224	6	4.320 V	3.980 V	
230	8	4.310 V	3.980 V	
236	10	4.310 V	3.980 V	
242	12	4.310 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-8.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	80.00MV		260.0MV
322	4	68.00MV		260.0MV
328	6	66.00MV		260.0MV
334	8	66.00MV		260.0MV
340	10	68.00MV		260.0MV
346	12	70.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-2.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-32.00NA	-100.0NA	100.0NA
390	3	-5.000NA	-100.0NA	100.0NA
395	5	-13.00NA	-100.0NA	100.0NA
398	5	6.000NA	-100.0NA	100.0NA
403	9	-11.00NA	-100.0NA	100.0NA
406	9	6.000NA	-100.0NA	100.0NA
411	11	-8.000NA	-100.0NA	100.0NA

414	11	5.000NA	-100.0NA	100.0NA
419	13	-6.000NA	-100.0NA	100.0NA
422	13	2.000NA	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	26.00NA		1.000UA
458	14	2.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	700.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	700.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
      0000000000    PASS  PASS   EOT

```


STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 5

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-660.0MV	-1.500 V	-100.0MV
57	3	-650.0MV	-1.500 V	-100.0MV
57	5	-660.0MV	-1.500 V	-100.0MV
57	9	-660.0MV	-1.500 V	-100.0MV
57	11	-660.0MV	-1.500 V	-100.0MV
57	13	-660.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.310 V	3.980 V	
218	4	4.310 V	3.980 V	
224	6	4.320 V	3.980 V	
230	8	4.310 V	3.980 V	
236	10	4.310 V	3.980 V	
242	12	4.310 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-8.000MV		100.0MV

275	6	-8.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	76.00MV		260.0MV
322	4	66.00MV		260.0MV
328	6	64.00MV		260.0MV
334	8	64.00MV		260.0MV
340	10	66.00MV		260.0MV
346	12	70.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-6.000MV		100.0MV
275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-2.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-7.000NA	-100.0NA	100.0NA
390	3	5.000NA	-100.0NA	100.0NA
395	5	-8.000NA	-100.0NA	100.0NA
398	5	9.000NA	-100.0NA	100.0NA
403	9	-9.000NA	-100.0NA	100.0NA
406	9	8.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA

414	11	6.000NA	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA
422	13	3.000NA	-100.0NA	100.0NA

 ICC TEST
 VCC= 6
 ICC LIMIT MAX. 1.0UA @25C/-55C
 ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	27.00NA		1.000UA
458	14	3.000NA		1.000UA

 ICC - DELTA TEST
 VCC= 5.5
 ICC LIMIT MAX. 2.4MA @25C/+125C
 ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	700.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	620.0UA		2.400MA
500	14	630.0UA		2.400MA
500	14	660.0UA		2.400MA

EIR 1.....10	FCT	DCT	
000000000	PASS	PASS	EOT

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 6

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-650.0MV	-1.500 V	-100.0MV
57	3	-650.0MV	-1.500 V	-100.0MV
57	5	-650.0MV	-1.500 V	-100.0MV
57	9	-650.0MV	-1.500 V	-100.0MV
57	11	-650.0MV	-1.500 V	-100.0MV
57	13	-650.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.300 V	3.980 V	
218	4	4.310 V	3.980 V	
224	6	4.310 V	3.980 V	
230	8	4.310 V	3.980 V	
236	10	4.310 V	3.980 V	
242	12	4.310 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-8.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-8.000MV		100.0MV
293	12	-8.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	80.00MV		260.0MV
322	4	68.00MV		260.0MV
328	6	68.00MV		260.0MV
334	8	66.00MV		260.0MV
340	10	70.00MV		260.0MV
346	12	70.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-2.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-2.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-7.000NA	-100.0NA	100.0NA
390	3	5.000NA	-100.0NA	100.0NA
395	5	-8.000NA	-100.0NA	100.0NA
398	5	9.000NA	-100.0NA	100.0NA
403	9	-9.000NA	-100.0NA	100.0NA
406	9	8.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA

414	11	6.000NA	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA
422	13	3.000NA	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	28.00NA		1.000UA
458	14	3.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	700.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	660.0UA		2.400MA
500	14	690.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 7

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-660.0MV	-1.500 V	-100.0MV
57	3	-650.0MV	-1.500 V	-100.0MV
57	5	-650.0MV	-1.500 V	-100.0MV
57	9	-650.0MV	-1.500 V	-100.0MV
57	11	-650.0MV	-1.500 V	-100.0MV
57	13	-650.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.310 V	3.980 V	
218	4	4.310 V	3.980 V	
224	6	4.320 V	3.980 V	
230	8	4.320 V	3.980 V	
236	10	4.320 V	3.980 V	
242	12	4.320 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-8.000MV		100.0MV
287	10	-8.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	76.00MV		260.0MV
322	4	66.00MV		260.0MV
328	6	64.00MV		260.0MV
334	8	64.00MV		260.0MV
340	10	66.00MV		260.0MV
346	12	66.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-2.000MV		100.0MV
269	4	-6.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-2.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-90.00NA	-100.0NA	100.0NA
390	3	-12.00NA	-100.0NA	100.0NA
395	5	-16.00NA	-100.0NA	100.0NA
398	5	4.000NA	-100.0NA	100.0NA
403	9	-12.00NA	-100.0NA	100.0NA
406	9	5.000NA	-100.0NA	100.0NA
411	11	-9.000NA	-100.0NA	100.0NA

414	11	4.000NA	-100.0NA	100.0NA
419	13	-7.000NA	-100.0NA	100.0NA
422	13	2.000NA	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	26.00NA		1.000UA
458	14	2.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	730.0UA		2.400MA
500	14	710.0UA		2.400MA
500	14	710.0UA		2.400MA
500	14	650.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	690.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 8

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-650.0MV	-1.500 V	-100.0MV
57	3	-660.0MV	-1.500 V	-100.0MV
57	5	-650.0MV	-1.500 V	-100.0MV
57	9	-660.0MV	-1.500 V	-100.0MV
57	11	-650.0MV	-1.500 V	-100.0MV
57	13	-660.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.300 V	3.980 V	
218	4	4.310 V	3.980 V	
224	6	4.320 V	3.980 V	
230	8	4.310 V	3.980 V	
236	10	4.310 V	3.980 V	
242	12	4.310 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-8.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-8.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	76.00MV		260.0MV
322	4	66.00MV		260.0MV
328	6	66.00MV		260.0MV
334	8	64.00MV		260.0MV
340	10	70.00MV		260.0MV
346	12	68.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-2.000MV		100.0MV
269	4	-6.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-2.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-32.00NA	-100.0NA	100.0NA
390	3	-5.000NA	-100.0NA	100.0NA
395	5	-13.00NA	-100.0NA	100.0NA
398	5	5.000NA	-100.0NA	100.0NA
403	9	-11.00NA	-100.0NA	100.0NA
406	9	6.000NA	-100.0NA	100.0NA
411	11	-8.000NA	-100.0NA	100.0NA

414	11	5.000NA	-100.0NA	100.0NA
419	13	-6.000NA	-100.0NA	100.0NA
422	13	2.000NA	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	26.00NA		1.000UA
458	14	2.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	690.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	630.0UA		2.400MA
500	14	640.0UA		2.400MA
500	14	670.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 9

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-650.0MV	-1.500 V	-100.0MV
57	3	-650.0MV	-1.500 V	-100.0MV
57	5	-650.0MV	-1.500 V	-100.0MV
57	9	-650.0MV	-1.500 V	-100.0MV
57	11	-650.0MV	-1.500 V	-100.0MV
57	13	-650.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.300 V	3.980 V	
218	4	4.310 V	3.980 V	
224	6	4.320 V	3.980 V	
230	8	4.310 V	3.980 V	
236	10	4.310 V	3.980 V	
242	12	4.310 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-8.000MV		100.0MV

275	6	-8.000MV		100.0MV
281	8	-8.000MV		100.0MV
287	10	-8.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	78.00MV		260.0MV
322	4	68.00MV		260.0MV
328	6	64.00MV		260.0MV
334	8	66.00MV		260.0MV
340	10	68.00MV		260.0MV
346	12	68.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-7.000NA	-100.0NA	100.0NA
390	3	5.000NA	-100.0NA	100.0NA
395	5	-8.000NA	-100.0NA	100.0NA
398	5	9.000NA	-100.0NA	100.0NA
403	9	-9.000NA	-100.0NA	100.0NA
406	9	8.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA

414	11	6.000NA	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA
422	13	3.000NA	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	28.00NA		1.000UA
458	14	3.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	660.0UA		2.400MA
500	14	640.0UA		2.400MA
500	14	630.0UA		2.400MA
500	14	600.0UA		2.400MA
500	14	600.0UA		2.400MA
500	14	630.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 10

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-660.0MV	-1.500 V	-100.0MV
57	3	-660.0MV	-1.500 V	-100.0MV
57	5	-650.0MV	-1.500 V	-100.0MV
57	9	-650.0MV	-1.500 V	-100.0MV
57	11	-650.0MV	-1.500 V	-100.0MV
57	13	-650.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.310 V	3.980 V	
218	4	4.310 V	3.980 V	
224	6	4.310 V	3.980 V	
230	8	4.310 V	3.980 V	
236	10	4.310 V	3.980 V	
242	12	4.310 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	80.00MV		260.0MV
322	4	66.00MV		260.0MV
328	6	66.00MV		260.0MV
334	8	66.00MV		260.0MV
340	10	70.00MV		260.0MV
346	12	68.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-7.000NA	-100.0NA	100.0NA
390	3	5.000NA	-100.0NA	100.0NA
395	5	-8.000NA	-100.0NA	100.0NA
398	5	9.000NA	-100.0NA	100.0NA
403	9	-9.000NA	-100.0NA	100.0NA
406	9	8.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA

414	11	6.000NA	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA
422	13	3.000NA	-100.0NA	100.0NA

```

-----
      ICC TEST
      VCC= 6
      ICC LIMIT MAX. 1.0UA @25C/-55C
      ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	27.00NA		1.000UA
458	14	3.000NA		1.000UA

```

-----
      ICC - DELTA TEST
      VCC= 5.5
      ICC LIMIT MAX. 2.4MA @25C/+125C
      ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	680.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	640.0UA		2.400MA
500	14	630.0UA		2.400MA
500	14	670.0UA		2.400MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS     EOT

```

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 11

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-650.0MV	-1.500 V	-100.0MV
57	3	-650.0MV	-1.500 V	-100.0MV
57	5	-650.0MV	-1.500 V	-100.0MV
57	9	-650.0MV	-1.500 V	-100.0MV
57	11	-650.0MV	-1.500 V	-100.0MV
57	13	-650.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.310 V	3.980 V	
218	4	4.310 V	3.980 V	
224	6	4.320 V	3.980 V	
230	8	4.320 V	3.980 V	
236	10	4.310 V	3.980 V	
242	12	4.310 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-8.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	76.00MV		260.0MV
322	4	66.00MV		260.0MV
328	6	64.00MV		260.0MV
334	8	64.00MV		260.0MV
340	10	64.00MV		260.0MV
346	12	66.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-2.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-2.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-90.00NA	-100.0NA	100.0NA
390	3	-12.00NA	-100.0NA	100.0NA
395	5	-16.00NA	-100.0NA	100.0NA
398	5	4.000NA	-100.0NA	100.0NA
403	9	-13.00NA	-100.0NA	100.0NA
406	9	6.000NA	-100.0NA	100.0NA
411	11	-9.000NA	-100.0NA	100.0NA

414	11	4.000NA	-100.0NA	100.0NA
419	13	-7.000NA	-100.0NA	100.0NA
422	13	2.000NA	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	26.00NA		1.000UA
458	14	2.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	730.0UA		2.400MA
500	14	710.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	700.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 12

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +25C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-650.0MV	-1.500 V	-100.0MV
57	3	-650.0MV	-1.500 V	-100.0MV
57	5	-650.0MV	-1.500 V	-100.0MV
57	9	-650.0MV	-1.500 V	-100.0MV
57	11	-650.0MV	-1.500 V	-100.0MV
57	13	-650.0MV	-1.500 V	-100.0MV
57	14	-520.0MV	-1.500 V	-100.0MV
67	2	570.0MV	100.0MV	1.500 V
67	4	570.0MV	100.0MV	1.500 V
67	6	570.0MV	100.0MV	1.500 V
67	8	570.0MV	100.0MV	1.500 V
67	10	570.0MV	100.0MV	1.500 V
67	12	570.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.460 V	4.400 V	
183	10	4.460 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.980

INST #	PIN	MEASURED	LT	GT
212	2	4.310 V	3.980 V	
218	4	4.310 V	3.980 V	
224	6	4.310 V	3.980 V	
230	8	4.310 V	3.980 V	
236	10	4.310 V	3.980 V	
242	12	4.310 V	3.980 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-8.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-8.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-8.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 260.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	78.00MV		260.0MV
322	4	68.00MV		260.0MV
328	6	68.00MV		260.0MV
334	8	66.00MV		260.0MV
340	10	70.00MV		260.0MV
346	12	70.00MV		260.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-2.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-2.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-4.000NA	-100.0NA	100.0NA
382	1	3.000NA	-100.0NA	100.0NA
387	3	-7.000NA	-100.0NA	100.0NA
390	3	5.000NA	-100.0NA	100.0NA
395	5	-8.000NA	-100.0NA	100.0NA
398	5	9.000NA	-100.0NA	100.0NA
403	9	-9.000NA	-100.0NA	100.0NA
406	9	9.000NA	-100.0NA	100.0NA
411	11	-7.000NA	-100.0NA	100.0NA

414	11	6.000NA	-100.0NA	100.0NA
419	13	-5.000NA	-100.0NA	100.0NA
422	13	3.000NA	-100.0NA	100.0NA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	28.00NA		1.000UA
458	14	3.000NA		1.000UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	680.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	630.0UA		2.400MA
500	14	630.0UA		2.400MA
500	14	660.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```




MIL-PRF-38534 CLASS K DATAPACK

Post Burn-In Test Results at +125°C



STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 1

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-560.0MV	-1.500 V	-100.0MV
57	3	-560.0MV	-1.500 V	-100.0MV
57	5	-560.0MV	-1.500 V	-100.0MV
57	9	-560.0MV	-1.500 V	-100.0MV
57	11	-550.0MV	-1.500 V	-100.0MV
57	13	-560.0MV	-1.500 V	-100.0MV
57	14	-410.0MV	-1.500 V	-100.0MV
67	2	460.0MV	100.0MV	1.500 V
67	4	460.0MV	100.0MV	1.500 V
67	6	460.0MV	100.0MV	1.500 V
67	8	460.0MV	100.0MV	1.500 V
67	10	460.0MV	100.0MV	1.500 V
67	12	460.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.270 V	3.700 V	
218	4	4.280 V	3.700 V	
224	6	4.280 V	3.700 V	
230	8	4.280 V	3.700 V	
236	10	4.280 V	3.700 V	
242	12	4.280 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV
275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV

287	10	-6.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	110.0MV		400.0MV
322	4	90.00MV		400.0MV
328	6	90.00MV		400.0MV
334	8	88.00MV		400.0MV
340	10	92.00MV		400.0MV
346	12	92.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	-2.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-7.000NA	-1.000UA	1.000UA
382	1	0 A	-1.000UA	1.000UA
387	3	-14.00NA	-1.000UA	1.000UA
390	3	-4.000NA	-1.000UA	1.000UA
395	5	-26.00NA	-1.000UA	1.000UA
398	5	-10.00NA	-1.000UA	1.000UA
403	9	-31.00NA	-1.000UA	1.000UA
406	9	-12.00NA	-1.000UA	1.000UA
411	11	-23.00NA	-1.000UA	1.000UA
414	11	-9.000NA	-1.000UA	1.000UA
419	13	-41.00NA	-1.000UA	1.000UA

422 13 1.000NA -1.000UA 1.000UA

ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	0 A		40.00UA
458	14	100.0NA		40.00UA

ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	730.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	710.0UA		2.400MA

EIR 1.....10 FCT DCT
0000000000 PASS PASS EOT

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 2

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-550.0MV	-1.500 V	-100.0MV
57	3	-540.0MV	-1.500 V	-100.0MV
57	5	-540.0MV	-1.500 V	-100.0MV
57	9	-540.0MV	-1.500 V	-100.0MV
57	11	-540.0MV	-1.500 V	-100.0MV
57	13	-540.0MV	-1.500 V	-100.0MV
57	14	-390.0MV	-1.500 V	-100.0MV
67	2	450.0MV	100.0MV	1.500 V
67	4	450.0MV	100.0MV	1.500 V
67	6	450.0MV	100.0MV	1.500 V
67	8	450.0MV	100.0MV	1.500 V
67	10	450.0MV	100.0MV	1.500 V
67	12	440.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.270 V	3.700 V	
218	4	4.270 V	3.700 V	
224	6	4.280 V	3.700 V	
230	8	4.280 V	3.700 V	
236	10	4.280 V	3.700 V	
242	12	4.280 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	106.0MV		400.0MV
322	4	90.00MV		400.0MV
328	6	88.00MV		400.0MV
334	8	86.00MV		400.0MV
340	10	90.00MV		400.0MV
346	12	88.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-2.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-2.000MV		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-7.000NA	-1.000UA	1.000UA
382	1	0 A	-1.000UA	1.000UA
387	3	-15.00NA	-1.000UA	1.000UA
390	3	-5.000NA	-1.000UA	1.000UA
395	5	-27.00NA	-1.000UA	1.000UA
398	5	-10.00NA	-1.000UA	1.000UA
403	9	-31.00NA	-1.000UA	1.000UA
406	9	-12.00NA	-1.000UA	1.000UA
411	11	-21.00NA	-1.000UA	1.000UA

414	11	-7.000NA	-1.000UA	1.000UA
419	13	-56.00NA	-1.000UA	1.000UA
422	13	2.000NA	-1.000UA	1.000UA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	100.0NA		40.00UA
458	14	200.0NA		40.00UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	750.0UA		2.400MA
500	14	710.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	730.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 3

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-540.0MV	-1.500 V	-100.0MV
57	3	-540.0MV	-1.500 V	-100.0MV
57	5	-540.0MV	-1.500 V	-100.0MV
57	9	-540.0MV	-1.500 V	-100.0MV
57	11	-540.0MV	-1.500 V	-100.0MV
57	13	-540.0MV	-1.500 V	-100.0MV
57	14	-390.0MV	-1.500 V	-100.0MV
67	2	450.0MV	100.0MV	1.500 V
67	4	450.0MV	100.0MV	1.500 V
67	6	450.0MV	100.0MV	1.500 V
67	8	450.0MV	100.0MV	1.500 V
67	10	450.0MV	100.0MV	1.500 V
67	12	450.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.700 V	
218	4	4.270 V	3.700 V	
224	6	4.280 V	3.700 V	
230	8	4.280 V	3.700 V	
236	10	4.270 V	3.700 V	
242	12	4.270 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-8.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	112.0MV		400.0MV
322	4	90.00MV		400.0MV
328	6	90.00MV		400.0MV
334	8	90.00MV		400.0MV
340	10	94.00MV		400.0MV
346	12	94.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-2.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-8.000NA	-1.000UA	1.000UA
382	1	0 A	-1.000UA	1.000UA
387	3	-18.00NA	-1.000UA	1.000UA
390	3	-6.000NA	-1.000UA	1.000UA
395	5	-32.00NA	-1.000UA	1.000UA
398	5	-12.00NA	-1.000UA	1.000UA
403	9	-31.00NA	-1.000UA	1.000UA
406	9	-12.00NA	-1.000UA	1.000UA
411	11	-20.00NA	-1.000UA	1.000UA

414	11	-7.000NA	-1.000UA	1.000UA
419	13	-64.00NA	-1.000UA	1.000UA
422	13	3.000NA	-1.000UA	1.000UA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	100.0NA		40.00UA
458	14	200.0NA		40.00UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	680.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	640.0UA		2.400MA
500	14	630.0UA		2.400MA
500	14	660.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 4

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-550.0MV	-1.500 V	-100.0MV
57	3	-550.0MV	-1.500 V	-100.0MV
57	5	-550.0MV	-1.500 V	-100.0MV
57	9	-550.0MV	-1.500 V	-100.0MV
57	11	-550.0MV	-1.500 V	-100.0MV
57	13	-550.0MV	-1.500 V	-100.0MV
57	14	-400.0MV	-1.500 V	-100.0MV
67	2	450.0MV	100.0MV	1.500 V
67	4	450.0MV	100.0MV	1.500 V
67	6	450.0MV	100.0MV	1.500 V
67	8	450.0MV	100.0MV	1.500 V
67	10	450.0MV	100.0MV	1.500 V
67	12	450.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.460 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.270 V	3.700 V	
218	4	4.270 V	3.700 V	
224	6	4.280 V	3.700 V	
230	8	4.280 V	3.700 V	
236	10	4.270 V	3.700 V	
242	12	4.280 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	108.0MV		400.0MV
322	4	90.00MV		400.0MV
328	6	90.00MV		400.0MV
334	8	86.00MV		400.0MV
340	10	92.00MV		400.0MV
346	12	90.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-2.000MV		100.0MV
293	12	-2.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-5.000NA	-1.000UA	1.000UA
382	1	3.000NA	-1.000UA	1.000UA
387	3	-8.000NA	-1.000UA	1.000UA
390	3	5.000NA	-1.000UA	1.000UA
395	5	-11.00NA	-1.000UA	1.000UA
398	5	10.00NA	-1.000UA	1.000UA
403	9	-12.00NA	-1.000UA	1.000UA
406	9	11.00NA	-1.000UA	1.000UA
411	11	-10.00NA	-1.000UA	1.000UA

414	11	9.000NA	-1.000UA	1.000UA
419	13	-72.00NA	-1.000UA	1.000UA
422	13	7.000NA	-1.000UA	1.000UA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	200.0NA		40.00UA
458	14	200.0NA		40.00UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	710.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	710.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 5

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-550.0MV	-1.500 V	-100.0MV
57	3	-550.0MV	-1.500 V	-100.0MV
57	5	-540.0MV	-1.500 V	-100.0MV
57	9	-540.0MV	-1.500 V	-100.0MV
57	11	-540.0MV	-1.500 V	-100.0MV
57	13	-540.0MV	-1.500 V	-100.0MV
57	14	-390.0MV	-1.500 V	-100.0MV
67	2	450.0MV	100.0MV	1.500 V
67	4	450.0MV	100.0MV	1.500 V
67	6	450.0MV	100.0MV	1.500 V
67	8	450.0MV	100.0MV	1.500 V
67	10	450.0MV	100.0MV	1.500 V
67	12	450.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.700 V	
218	4	4.280 V	3.700 V	
224	6	4.280 V	3.700 V	
230	8	4.280 V	3.700 V	
236	10	4.280 V	3.700 V	
242	12	4.280 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-8.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	108.0MV		400.0MV
322	4	88.00MV		400.0MV
328	6	88.00MV		400.0MV
334	8	88.00MV		400.0MV
340	10	92.00MV		400.0MV
346	12	94.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-2.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-2.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-5.000NA	-1.000UA	1.000UA
382	1	3.000NA	-1.000UA	1.000UA
387	3	-8.000NA	-1.000UA	1.000UA
390	3	5.000NA	-1.000UA	1.000UA
395	5	-11.00NA	-1.000UA	1.000UA
398	5	10.00NA	-1.000UA	1.000UA
403	9	-12.00NA	-1.000UA	1.000UA
406	9	11.00NA	-1.000UA	1.000UA
411	11	-10.00NA	-1.000UA	1.000UA

414	11	9.000NA	-1.000UA	1.000UA
419	13	-78.00NA	-1.000UA	1.000UA
422	13	8.000NA	-1.000UA	1.000UA

```

-----
      ICC TEST
      VCC= 6
      ICC LIMIT MAX. 1.0UA @25C/-55C
      ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	200.0NA		40.00UA
458	14	200.0NA		40.00UA

```

-----
      ICC - DELTA TEST
      VCC= 5.5
      ICC LIMIT MAX. 2.4MA @25C/+125C
      ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	710.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	630.0UA		2.400MA
500	14	640.0UA		2.400MA
500	14	670.0UA		2.400MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS     EOT

```


STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 6

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-560.0MV	-1.500 V	-100.0MV
57	3	-560.0MV	-1.500 V	-100.0MV
57	5	-560.0MV	-1.500 V	-100.0MV
57	9	-560.0MV	-1.500 V	-100.0MV
57	11	-560.0MV	-1.500 V	-100.0MV
57	13	-550.0MV	-1.500 V	-100.0MV
57	14	-400.0MV	-1.500 V	-100.0MV
67	2	460.0MV	100.0MV	1.500 V
67	4	460.0MV	100.0MV	1.500 V
67	6	460.0MV	100.0MV	1.500 V
67	8	460.0MV	100.0MV	1.500 V
67	10	460.0MV	100.0MV	1.500 V
67	12	450.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.460 V	4.400 V	
165	4	4.460 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.460 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.700 V	
218	4	4.280 V	3.700 V	
224	6	4.280 V	3.700 V	
230	8	4.280 V	3.700 V	
236	10	4.280 V	3.700 V	
242	12	4.280 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-8.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	108.0MV		400.0MV
322	4	88.00MV		400.0MV
328	6	88.00MV		400.0MV
334	8	86.00MV		400.0MV
340	10	92.00MV		400.0MV
346	12	90.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-2.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-2.000MV		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-5.000NA	-1.000UA	1.000UA
382	1	4.000NA	-1.000UA	1.000UA
387	3	-8.000NA	-1.000UA	1.000UA
390	3	5.000NA	-1.000UA	1.000UA
395	5	-12.00NA	-1.000UA	1.000UA
398	5	12.00NA	-1.000UA	1.000UA
403	9	-13.00NA	-1.000UA	1.000UA
406	9	12.00NA	-1.000UA	1.000UA
411	11	-11.00NA	-1.000UA	1.000UA

414	11	10.00NA	-1.000UA	1.000UA
419	13	-83.00NA	-1.000UA	1.000UA
422	13	8.000NA	-1.000UA	1.000UA

```

-----
      ICC TEST
      VCC= 6
      ICC LIMIT MAX. 1.0UA @25C/-55C
      ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	200.0NA		40.00UA
458	14	100.0NA		40.00UA

```

-----
      ICC - DELTA TEST
      VCC= 5.5
      ICC LIMIT MAX. 2.4MA @25C/+125C
      ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	710.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	690.0UA		2.400MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS     EOT

```

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 7

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-560.0MV	-1.500 V	-100.0MV
57	3	-560.0MV	-1.500 V	-100.0MV
57	5	-560.0MV	-1.500 V	-100.0MV
57	9	-560.0MV	-1.500 V	-100.0MV
57	11	-550.0MV	-1.500 V	-100.0MV
57	13	-550.0MV	-1.500 V	-100.0MV
57	14	-400.0MV	-1.500 V	-100.0MV
67	2	460.0MV	100.0MV	1.500 V
67	4	460.0MV	100.0MV	1.500 V
67	6	460.0MV	100.0MV	1.500 V
67	8	460.0MV	100.0MV	1.500 V
67	10	460.0MV	100.0MV	1.500 V
67	12	450.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.270 V	3.700 V	
218	4	4.280 V	3.700 V	
224	6	4.290 V	3.700 V	
230	8	4.280 V	3.700 V	
236	10	4.280 V	3.700 V	
242	12	4.280 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-8.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	104.0MV		400.0MV
322	4	88.00MV		400.0MV
328	6	86.00MV		400.0MV
334	8	84.00MV		400.0MV
340	10	88.00MV		400.0MV
346	12	90.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.450 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	-4.000MV		100.0MV
275	6	-2.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-2.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-5.000NA	-1.000UA	1.000UA
382	1	4.000NA	-1.000UA	1.000UA
387	3	-8.000NA	-1.000UA	1.000UA
390	3	6.000NA	-1.000UA	1.000UA
395	5	-12.00NA	-1.000UA	1.000UA
398	5	13.00NA	-1.000UA	1.000UA
403	9	-13.00NA	-1.000UA	1.000UA
406	9	12.00NA	-1.000UA	1.000UA
411	11	-10.00NA	-1.000UA	1.000UA

414	11	10.00NA	-1.000UA	1.000UA
419	13	-78.00NA	-1.000UA	1.000UA
422	13	9.000NA	-1.000UA	1.000UA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	200.0NA		40.00UA
458	14	200.0NA		40.00UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	730.0UA		2.400MA
500	14	720.0UA		2.400MA
500	14	720.0UA		2.400MA
500	14	660.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	700.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 8

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-550.0MV	-1.500 V	-100.0MV
57	3	-550.0MV	-1.500 V	-100.0MV
57	5	-550.0MV	-1.500 V	-100.0MV
57	9	-550.0MV	-1.500 V	-100.0MV
57	11	-550.0MV	-1.500 V	-100.0MV
57	13	-540.0MV	-1.500 V	-100.0MV
57	14	-390.0MV	-1.500 V	-100.0MV
67	2	450.0MV	100.0MV	1.500 V
67	4	450.0MV	100.0MV	1.500 V
67	6	450.0MV	100.0MV	1.500 V
67	8	450.0MV	100.0MV	1.500 V
67	10	450.0MV	100.0MV	1.500 V
67	12	450.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.700 V	
218	4	4.280 V	3.700 V	
224	6	4.280 V	3.700 V	
230	8	4.280 V	3.700 V	
236	10	4.270 V	3.700 V	
242	12	4.280 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-8.000MV		100.0MV

275	6	-6.000MV	100.0MV
281	8	-6.000MV	100.0MV
287	10	-6.000MV	100.0MV
293	12	-6.000MV	100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	106.0MV		400.0MV
322	4	90.00MV		400.0MV
328	6	88.00MV		400.0MV
334	8	86.00MV		400.0MV
340	10	90.00MV		400.0MV
346	12	92.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-2.000MV		100.0MV
269	4	-2.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-2.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-2.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-5.000NA	-1.000UA	1.000UA
382	1	4.000NA	-1.000UA	1.000UA
387	3	-8.000NA	-1.000UA	1.000UA
390	3	6.000NA	-1.000UA	1.000UA
395	5	-12.00NA	-1.000UA	1.000UA
398	5	12.00NA	-1.000UA	1.000UA
403	9	-13.00NA	-1.000UA	1.000UA
406	9	12.00NA	-1.000UA	1.000UA
411	11	-10.00NA	-1.000UA	1.000UA

414	11	10.00NA	-1.000UA	1.000UA
419	13	-85.00NA	-1.000UA	1.000UA
422	13	9.000NA	-1.000UA	1.000UA

```

-----
      ICC TEST
      VCC= 6
      ICC LIMIT MAX. 1.0UA @25C/-55C
      ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	200.0NA		40.00UA
458	14	200.0NA		40.00UA

```

-----
      ICC - DELTA TEST
      VCC= 5.5
      ICC LIMIT MAX. 2.4MA @25C/+125C
      ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	700.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	650.0UA		2.400MA
500	14	650.0UA		2.400MA
500	14	680.0UA		2.400MA

```

EIR 1.....10      FCT      DCT
      0000000000    PASS     PASS     EOT

```

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 9

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-540.0MV	-1.500 V	-100.0MV
57	3	-540.0MV	-1.500 V	-100.0MV
57	5	-540.0MV	-1.500 V	-100.0MV
57	9	-540.0MV	-1.500 V	-100.0MV
57	11	-540.0MV	-1.500 V	-100.0MV
57	13	-540.0MV	-1.500 V	-100.0MV
57	14	-390.0MV	-1.500 V	-100.0MV
67	2	450.0MV	100.0MV	1.500 V
67	4	450.0MV	100.0MV	1.500 V
67	6	450.0MV	100.0MV	1.500 V
67	8	450.0MV	100.0MV	1.500 V
67	10	450.0MV	100.0MV	1.500 V
67	12	450.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.270 V	3.700 V	
218	4	4.270 V	3.700 V	
224	6	4.280 V	3.700 V	
230	8	4.280 V	3.700 V	
236	10	4.270 V	3.700 V	
242	12	4.270 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-4.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-8.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	110.0MV		400.0MV
322	4	90.00MV		400.0MV
328	6	88.00MV		400.0MV
334	8	88.00MV		400.0MV
340	10	92.00MV		400.0MV
346	12	92.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.460 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-2.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-5.000NA	-1.000UA	1.000UA
382	1	4.000NA	-1.000UA	1.000UA
387	3	-8.000NA	-1.000UA	1.000UA
390	3	6.000NA	-1.000UA	1.000UA
395	5	-13.00NA	-1.000UA	1.000UA
398	5	13.00NA	-1.000UA	1.000UA
403	9	-13.00NA	-1.000UA	1.000UA
406	9	12.00NA	-1.000UA	1.000UA
411	11	-10.00NA	-1.000UA	1.000UA

414	11	10.00NA	-1.000UA	1.000UA
419	13	-80.00NA	-1.000UA	1.000UA
422	13	9.000NA	-1.000UA	1.000UA

 ICC TEST
 VCC= 6
 ICC LIMIT MAX. 1.0UA @25C/-55C
 ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	200.0NA		40.00UA
458	14	100.0NA		40.00UA

 ICC - DELTA TEST
 VCC= 5.5
 ICC LIMIT MAX. 2.4MA @25C/+125C
 ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	670.0UA		2.400MA
500	14	650.0UA		2.400MA
500	14	640.0UA		2.400MA
500	14	610.0UA		2.400MA
500	14	620.0UA		2.400MA
500	14	640.0UA		2.400MA

EIR 1.....10 FCT DCT
 0000000000 PASS PASS EOT

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 10

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-540.0MV	-1.500 V	-100.0MV
57	3	-540.0MV	-1.500 V	-100.0MV
57	5	-540.0MV	-1.500 V	-100.0MV
57	9	-540.0MV	-1.500 V	-100.0MV
57	11	-540.0MV	-1.500 V	-100.0MV
57	13	-540.0MV	-1.500 V	-100.0MV
57	14	-380.0MV	-1.500 V	-100.0MV
67	2	450.0MV	100.0MV	1.500 V
67	4	450.0MV	100.0MV	1.500 V
67	6	440.0MV	100.0MV	1.500 V
67	8	450.0MV	100.0MV	1.500 V
67	10	440.0MV	100.0MV	1.500 V
67	12	440.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.700 V	
218	4	4.270 V	3.700 V	
224	6	4.280 V	3.700 V	
230	8	4.270 V	3.700 V	
236	10	4.270 V	3.700 V	
242	12	4.270 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-6.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	112.0MV		400.0MV
322	4	92.00MV		400.0MV
328	6	92.00MV		400.0MV
334	8	90.00MV		400.0MV
340	10	94.00MV		400.0MV
346	12	94.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.460 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.460 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	0 V		100.0MV
269	4	-2.000MV		100.0MV
275	6	-2.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-6.000NA	-1.000UA	1.000UA
382	1	4.000NA	-1.000UA	1.000UA
387	3	-8.000NA	-1.000UA	1.000UA
390	3	6.000NA	-1.000UA	1.000UA
395	5	-12.00NA	-1.000UA	1.000UA
398	5	13.00NA	-1.000UA	1.000UA
403	9	-13.00NA	-1.000UA	1.000UA
406	9	12.00NA	-1.000UA	1.000UA
411	11	-10.00NA	-1.000UA	1.000UA

414	11	10.00NA	-1.000UA	1.000UA
419	13	-77.00NA	-1.000UA	1.000UA
422	13	9.000NA	-1.000UA	1.000UA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	300.0NA		40.00UA
458	14	200.0NA		40.00UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	680.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	670.0UA		2.400MA
500	14	650.0UA		2.400MA
500	14	640.0UA		2.400MA
500	14	670.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 11

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-540.0MV	-1.500 V	-100.0MV
57	3	-540.0MV	-1.500 V	-100.0MV
57	5	-540.0MV	-1.500 V	-100.0MV
57	9	-540.0MV	-1.500 V	-100.0MV
57	11	-540.0MV	-1.500 V	-100.0MV
57	13	-540.0MV	-1.500 V	-100.0MV
57	14	-390.0MV	-1.500 V	-100.0MV
67	2	450.0MV	100.0MV	1.500 V
67	4	450.0MV	100.0MV	1.500 V
67	6	450.0MV	100.0MV	1.500 V
67	8	440.0MV	100.0MV	1.500 V
67	10	450.0MV	100.0MV	1.500 V
67	12	440.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.270 V	3.700 V	
218	4	4.270 V	3.700 V	
224	6	4.280 V	3.700 V	
230	8	4.280 V	3.700 V	
236	10	4.280 V	3.700 V	
242	12	4.280 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-8.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-6.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	106.0MV		400.0MV
322	4	86.00MV		400.0MV
328	6	86.00MV		400.0MV
334	8	82.00MV		400.0MV
340	10	88.00MV		400.0MV
346	12	90.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.450 V	5.400 V	
171	6	5.460 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-2.000MV		100.0MV
269	4	-4.000MV		100.0MV
275	6	-4.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	0 V		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-5.000NA	-1.000UA	1.000UA
382	1	4.000NA	-1.000UA	1.000UA
387	3	-8.000NA	-1.000UA	1.000UA
390	3	6.000NA	-1.000UA	1.000UA
395	5	-13.00NA	-1.000UA	1.000UA
398	5	14.00NA	-1.000UA	1.000UA
403	9	-13.00NA	-1.000UA	1.000UA
406	9	12.00NA	-1.000UA	1.000UA
411	11	-11.00NA	-1.000UA	1.000UA

414	11	10.00NA	-1.000UA	1.000UA
419	13	-83.00NA	-1.000UA	1.000UA
422	13	10.00NA	-1.000UA	1.000UA

 ICC TEST
 VCC= 6
 ICC LIMIT MAX. 1.0UA @25C/-55C
 ICC LIMIT MAX. 40UA @+125C

INST #	PIN	MEASURED	LT	GT
451	14	200.0NA		40.00UA
458	14	200.0NA		40.00UA

 ICC - DELTA TEST
 VCC= 5.5
 ICC LIMIT MAX. 2.4MA @25C/+125C
 ICC LIMIT MAX. 2.9MA @-55C

INST #	PIN	MEASURED	LT	GT
500	14	740.0UA		2.400MA
500	14	720.0UA		2.400MA
500	14	710.0UA		2.400MA
500	14	700.0UA		2.400MA
500	14	690.0UA		2.400MA
500	14	710.0UA		2.400MA

EIR 1.....10	FCT	DCT	
0000000000	PASS	PASS	EOT

STAT1 09/10/11 08:09
TEST PROGRAM HCT04 S/N 12

DDS-101-13-A PN 54HCT04 ELECTRICAL TEST SEQ 14 +125C

CONTINUITY TEST

INST #	PIN	MEASURED	LT	GT
57	1	-530.0MV	-1.500 V	-100.0MV
57	3	-530.0MV	-1.500 V	-100.0MV
57	5	-530.0MV	-1.500 V	-100.0MV
57	9	-530.0MV	-1.500 V	-100.0MV
57	11	-530.0MV	-1.500 V	-100.0MV
57	13	-520.0MV	-1.500 V	-100.0MV
57	14	-370.0MV	-1.500 V	-100.0MV
67	2	430.0MV	100.0MV	1.500 V
67	4	430.0MV	100.0MV	1.500 V
67	6	430.0MV	100.0MV	1.500 V
67	8	430.0MV	100.0MV	1.500 V
67	10	430.0MV	100.0MV	1.500 V
67	12	430.0MV	100.0MV	1.500 V

FUNCTIONAL TEST
VCC= 4.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 4.500
VOH LIMIT 4.400

INST #	PIN	MEASURED	LT	GT
159	2	4.450 V	4.400 V	
165	4	4.450 V	4.400 V	
171	6	4.450 V	4.400 V	
177	8	4.450 V	4.400 V	
183	10	4.450 V	4.400 V	
189	12	4.450 V	4.400 V	

VOH2 TEST
VCC= 4.500
VOH2 LIMIT 3.700

INST #	PIN	MEASURED	LT	GT
212	2	4.260 V	3.700 V	
218	4	4.270 V	3.700 V	
224	6	4.280 V	3.700 V	
230	8	4.270 V	3.700 V	
236	10	4.270 V	3.700 V	
242	12	4.270 V	3.700 V	

VOL1 TEST
VCC= 4.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-6.000MV		100.0MV
269	4	-4.000MV		100.0MV

275	6	-6.000MV		100.0MV
281	8	-6.000MV		100.0MV
287	10	-6.000MV		100.0MV
293	12	-8.000MV		100.0MV

VOL2 TEST
VCC= 4.500
VOL2 LIMIT 400.0E-03

INST #	PIN	MEASURED	LT	GT
316	2	112.0MV		400.0MV
322	4	94.00MV		400.0MV
328	6	92.00MV		400.0MV
334	8	90.00MV		400.0MV
340	10	96.00MV		400.0MV
346	12	96.00MV		400.0MV

FUNCTIONAL TEST
VCC= 5.500
VIH= 2 VIL= 800.0E-03

VOH1 TEST
VCC= 5.500
VOH LIMIT 5.400

INST #	PIN	MEASURED	LT	GT
159	2	5.460 V	5.400 V	
165	4	5.460 V	5.400 V	
171	6	5.450 V	5.400 V	
177	8	5.450 V	5.400 V	
183	10	5.450 V	5.400 V	
189	12	5.450 V	5.400 V	

VOL1 TEST
VCC= 5.500
VOL LIMIT 100.0E-03

INST #	PIN	MEASURED	LT	GT
263	2	-4.000MV		100.0MV
269	4	-2.000MV		100.0MV
275	6	-2.000MV		100.0MV
281	8	-4.000MV		100.0MV
287	10	-4.000MV		100.0MV
293	12	-4.000MV		100.0MV

IIN TEST
VCC= 5.5
IIL/IIH LIMIT +- 0.1UA @25C/-55C
IIL/IIH LIMIT +- 1.0UA @+125C

INST #	PIN	MEASURED	LT	GT
379	1	-7.000NA	-1.000UA	1.000UA
382	1	7.000NA	-1.000UA	1.000UA
387	3	-16.00NA	-1.000UA	1.000UA
390	3	15.00NA	-1.000UA	1.000UA
395	5	-30.00NA	-1.000UA	1.000UA
398	5	43.00NA	-1.000UA	1.000UA
403	9	-30.00NA	-1.000UA	1.000UA
406	9	41.00NA	-1.000UA	1.000UA
411	11	-32.00NA	-1.000UA	1.000UA

414	11	42.00NA	-1.000UA	1.000UA
419	13	-89.00NA	-1.000UA	1.000UA
422	13	17.00NA	-1.000UA	1.000UA

```

-----
ICC TEST
VCC= 6
ICC LIMIT MAX. 1.0UA @25C/-55C
ICC LIMIT MAX. 40UA @+125C
-----

```

INST #	PIN	MEASURED	LT	GT
451	14	400.0NA		40.00UA
458	14	300.0NA		40.00UA

```

-----
ICC - DELTA TEST
VCC= 5.5
ICC LIMIT MAX. 2.4MA @25C/+125C
ICC LIMIT MAX. 2.9MA @-55C
-----

```

INST #	PIN	MEASURED	LT	GT
500	14	690.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	680.0UA		2.400MA
500	14	650.0UA		2.400MA
500	14	640.0UA		2.400MA
500	14	670.0UA		2.400MA

```

EIR 1.....10      FCT   DCT
0000000000      PASS  PASS   EOT

```



MIL-PRF-38534 CLASS K DATAPACK

Scanning Electron Microscopy (SEM) analysis



TANDEX TEST LABS, INC.

15849 Business Ctr. Dr. Irwindale CA. 91706

Phone: (626)-962-7166 Fax: (626)-960-6896

SCANNING ELECTRON MICROSCOPE ANALYSIS

DIE DEVICES

TTL Job # DDS-101-13-W

Date: June 28, 2018

Part Number: 54HCT04

Part Type: CMOS LOGIC MICROCIRCUIT

Lot: Lot# 80393 D/C: 1810 WFR# 48


Quantity: Eight (8)

Purchase Order: SS139

Submitted by: _____


Jason A. Salinas
DPA/MTS

Approved by: _____


Deborah M. Gorham
Quality Assurance

TANDEX TEST LABS TTL Job # DDS-101-13-W

Summary

Eight (8) CMOS Logic Microcircuit P/N: 54HCT04 were submitted by Die Devices for Scanning Electron Microscopy Analysis. This Analysis was performed in accordance with Mil-Std-883, Method 2018.6 The devices were assigned sample number 1 through 8 by Tandex Test Labs.

1. **Plasma Etching** Carbon Tetrafluoride Gas 92% and 8% Oxygen was used to remove the glassivation. This etching is destructive and uneven in the rates of glass removal in various areas of the die.
2. **SEM Inspection** was performed on all eight devices. All eight devices revealed adequate metallization coverage and met the requirements of MIL-STD-883, Method 2018.6. See DPA form on page 3 and figures 1 through 3, for typical photographs.

Conclusion: This lot is acceptable for use.

TANDEX TEST LABS TTL Job # DDS-101-13-W
SEM EXAMINATION

TTL Job No. DDS-101-13-W	Part Number 54HCT04	Part Type CMOS Logic Microcircuit	Date June 28, 2018
Lot Date Code: WFR# 48 Lot# 80393 D/C: 1810	Sample Qty. 8	Serial Numbers 1 - 8	Test Specifications Mil-Std-883 Method 2018.6
Misc. ID No.	Qty. Accept 8	Qty. Reject 0	Qty. Suspect 0

Notes:

S/N	Investigation Findings / Comments	A/R/S
1	No Anomalies	A
2	No Anomalies	A
3	No Anomalies	A
4	No Anomalies	A
5	No Anomalies	A
6	No Anomalies	A
7	No Anomalies	A
8	No Anomalies	A

Each sample was inspected for the general metallization condition at a magnification between 1,000 X and 6,000 X over 25% of the total metallization (unless specified differently). Each sample was inspected from four (4) viewing directions at a magnification between 5,000 X and 20,000 X

Inspection required Yes: No: Devices constructed with expanded Metallization Yes: No:

Sample Glassivated Yes: No: Dual Level Metallization Yes: No:

Glassivation Removed Using: PLASMA ETCHING

Beam accelerating voltage 10kV to 20kV Viewing angle 45 deg



Technician Stamp:

TANDEX TEST LABS TTL Job # DDS-101-13-W

Photodocumentation

TANDEX TEST LABS, INC.

15849 Business Center. Dr., Irwindale CA. 91706

Phone: (626)962-7166 FAX: (626)960-6896

<http://www.tandexlabs.com>

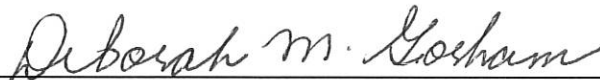
e-mail: via web site

Certificate of Conformance

CUSTOMER:	Silicon Supplies Limited 47 Wherry Road Norwich, NR1, 1WS United Kingdom Vat GB# 114 3513 56	DATE: June 28, 2018
TEST REPORT:	DDS-101-13-W	QUANTITY REQUIRED: 8
P.O. NUMBER:	SS139	QUANTITY PROCESSED: 8
DESCRIPTION:	CMOS LOGIC MICROCIRCUIT	QUANTITY PASSED: 8
PART NUMBER(S):	54HCT04	QUANTITY FAILED: 0
MFG PART NUMBER	54HCT04	QUANTITY SHIPPING: 8
LOT / DATE CODE:	LOT# 80393 WFR# 48 D/C: 1810	
MFG:	SILICON SUPPLIES	

METHOD OF TESTING: MIL-STD-883 METHOD 2018.6

I hereby certify that the subject components have been processed and inspected in accordance with instructions with specifications referenced in your purchase order. Physical records and/or data pertinent to applicable military, proprietary, and/or commercial specifications are on file and available upon request for inspection at this facility.



Deborah M. Gorham
QUALITY ASSURANCE

